

TRANSMITTAL LETTER TO THE UNITED STATES
DESIGNATED/ELECTED OFFICE (DO/EO/US)
CONCERNING A FILING UNDER 35 U.S.C. 371

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U.S. APPLICATION NO. (IF KNOWN, SEE 37 CFR

09/486779

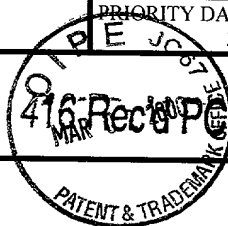
INTERNATIONAL APPLICATION NO.
PCT/US98/20594INTERNATIONAL FILING DATE
30 September 1998PRIORITY DATE CLAIMED
30 September 1997

TITLE OF INVENTION

EMITTER TURN-OFF THYRISTORS (ETO)

APPLICANT(S) FOR DO/EO/US

Alex Q. Huang



02 MAR 2000

Applicant herewith submits to the United States Designated/Elected Office (DO/EO/US) the following items and other information:

1. ☒ This is a **FIRST** submission of items concerning a filing under 35 U.S.C. 371.
2. ☐ This is a **SECOND** or **SUBSEQUENT** submission of items concerning a filing under 35 U.S.C. 371.
3. ☒ This is an express request to begin national examination procedures (35 U.S.C. 371(f)) at any time rather than delay examination until the expiration of the applicable time limit set in 35 U.S.C. 371(b) and PCT Articles 22 and 39(1).
4. ☒ A proper Demand for International Preliminary Examination was made by the 19th month from the earliest claimed priority date.
5. ☒ A copy of the International Application as filed (35 U.S.C. 371 (c) (2))
 - a. ☐ is transmitted herewith (required only if not transmitted by the International Bureau).
 - b. ☒ has been transmitted by the International Bureau.
 - c. ☐ is not required, as the application was filed in the United States Receiving Office (RO/US).
6. ☐ A translation of the International Application into English (35 U.S.C. 371(c)(2)).
7. ☒ A copy of the International Search Report (PCT/ISA/210).
8. ☐ Amendments to the claims of the International Application under PCT Article 19 (35 U.S.C. 371 (c)(3))
 - a. ☐ are transmitted herewith (required only if not transmitted by the International Bureau).
 - b. ☐ have been transmitted by the International Bureau.
 - c. ☐ have not been made; however, the time limit for making such amendments has NOT expired.
 - d. ☐ have not been made and will not be made.
9. ☐ A translation of the amendments to the claims under PCT Article 19 (35 U.S.C. 371(c)(3)).
10. ☒ An oath or declaration of the inventor(s) (35 U.S.C. 371 (c)(4)).
11. ☒ A copy of the International Preliminary Examination Report (PCT/IPEA/409).
12. ☐ A translation of the annexes to the International Preliminary Examination Report under PCT Article 36 (35 U.S.C. 371 (c)(5)).

Items 13 to 20 below concern document(s) or information included:

13. ☐ An Information Disclosure Statement under 37 CFR 1.97 and 1.98.
14. ☐ An assignment document for recording. A separate cover sheet in compliance with 37 CFR 3.28 and 3.31 is included.
15. ☐ A **FIRST** preliminary amendment.
16. ☐ A **SECOND** or **SUBSEQUENT** preliminary amendment.
17. ☐ A substitute specification.
18. ☐ A change of power of attorney and/or address letter.
19. ☐ Certificate of Mailing by Express Mail
20. ☐ Other items or information:

U.S. APPLICATION NO. (IF KNOWN, SEE 37 CFR 1.492(a)(1)) 09/486779		INTERNATIONAL APPLICATION NO. PCT/US98/20594		ATTORNEY'S DOCKET NUMBER 01640052AA	
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21. The following fees are submitted: BASIC NATIONAL FEE (37 CFR 1.492 (a) (1) - (5)) : <ul style="list-style-type: none"> <input type="checkbox"/> Neither international preliminary examination fee (37 CFR 1.482) nor international search fee (37 CFR 1.445(a)(2)) paid to USPTO and International Search Report not prepared by the EPO or JPO \$970.00 <input type="checkbox"/> International preliminary examination fee (37 CFR 1.482) not paid to USPTO but International Search Report prepared by the EPO or JPO \$840.00 <input type="checkbox"/> International preliminary examination fee (37 CFR 1.482) not paid to USPTO but international search fee (37 CFR 1.445(a)(2)) paid to USPTO \$690.00 <input type="checkbox"/> International preliminary examination fee paid to USPTO (37 CFR 1.482) but all claims did not satisfy provisions of PCT Article 33(1)-(4) \$670.00 <input checked="" type="checkbox"/> International preliminary examination fee paid to USPTO (37 CFR 1.482) and all claims satisfied provisions of PCT Article 33(1)-(4) \$96.00 				CALCULATIONS PTO USE ONLY	
ENTER APPROPRIATE BASIC FEE AMOUNT =				\$96.00	
Surcharge of \$130.00 for furnishing the oath or declaration later than months from the earliest claimed priority date (37 CFR 1.492 (e)). <input type="checkbox"/> 20 <input type="checkbox"/> 30				\$0.00	
CLAIMS	NUMBER FILED	NUMBER EXTRA	RATE		
Total claims	32 - 20 =	12	x \$18.00	\$216.00	
Independent claims	6 - 3 =	3	x \$78.00	\$234.00	
Multiple Dependent Claims (check if applicable). <input type="checkbox"/>				\$0.00	
TOTAL OF ABOVE CALCULATIONS =				\$546.00	
Reduction of 1/2 for filing by small entity, if applicable. Verified Small Entity Statement must also be filed (Note 37 CFR 1.9, 1.27, 1.28) (check if applicable). <input checked="" type="checkbox"/>				\$273.00	
SUBTOTAL =				\$273.00	
Processing fee of \$130.00 for furnishing the English translation later than months from the earliest claimed priority date (37 CFR 1.492 (f)). <input type="checkbox"/> 20 <input type="checkbox"/> 30				\$0.00	
TOTAL NATIONAL FEE =				\$273.00	
Fee for recording the enclosed assignment (37 CFR 1.21(h)). The assignment must be accompanied by an appropriate cover sheet (37 CFR 3.28, 3.31) (check if applicable). <input type="checkbox"/>				\$0.00	
TOTAL FEES ENCLOSED =				\$273.00	
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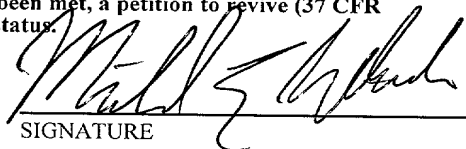
☒ A check in the amount of **\$273.00** to cover the above fees is enclosed.

☐ Please charge my Deposit Account No. _____ in the amount of _____ to cover the above fees.
A duplicate copy of this sheet is enclosed.

☒ The Commissioner is hereby authorized to charge any fees which may be required, or credit any overpayment to Deposit Account No. **23-1951** A duplicate copy of this sheet is enclosed.

NOTE: Where an appropriate time limit under 37 CFR 1.494 or 1.495 has not been met, a petition to revive (37 CFR 1.137(a) or (b)) must be filed and granted to restore the application to pending status.

SEND ALL CORRESPONDENCE TO:

Michael E. Whitham Whitham, Curtis & Whitham Registration No. 32,635 11800 Sunrise Valley Drive Suite 900 Reston, Virginia 20191	<div style="text-align: center;">  SIGNATURE </div> <div style="text-align: center;"> Michael E. Whitham NAME </div> <div style="text-align: center;"> 32,635 REGISTRATION NUMBER </div> <div style="text-align: center;"> March 2, 2000 DATE </div>
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Docket No.: 96-037

VERIFIED STATEMENT (DECLARATION) CLAIMING SMALL ENTITY STATUS

(37 C.F.R. §§1.9(f) and 1.27 (d)) - NONPROFIT ORGANIZATION

I hereby declare that I am an official empowered to act on behalf of the nonprofit organization identified below:

NAME OF ORGANIZATION Virginia Tech Intellectual Properties, Inc.
ADDRESS OF ORGANIZATION 1872 Pratt Drive, Suite 1625, Blacksburg, Virginia 24060

TYPE OF ORGANIZATION

- (check one) ☐ UNIVERSITY OR OTHER INSTITUTION OF HIGHER LEARNING
- ☒ TAX EXEMPT UNDER INTERNAL REVENUE SERVICE CODE (26 USC 501(a) and 501(c)(3))
- ☐ NONPROFIT SCIENTIFIC OR EDUCATIONAL UNDER STATUTE OF STATE OF THE UNITED STATES OF AMERICA
(NAME OF STATE _____)
(CITATION OF STATUTE _____)
- ☐ WOULD QUALIFY AS TAX EXEMPT UNDER INTERNAL REVENUE SERVICE CODE (26 USC 501(a) and 501(c)(3)) IF LOCATED IN UNITED STATES OF AMERICA
- ☐ WOULD QUALIFY AS NONPROFIT SCIENTIFIC OR EDUCATIONAL UNDER STATUTE OF STATE OF THE UNITED STATES OF AMERICA IF LOCATED IN THE UNITED STATES OF AMERICA
(NAME OF STATE _____)
(CITATION OF STATUTE _____)

I hereby declare that the above identified nonprofit organization qualifies as a nonprofit organization as defined in 37 C.F.R. §1.9(e), for purposes of paying reduced fees under section 41(a) and (b) of Title 35, United States Code, with regard to the invention entitled EMITTER TURN-OFF THYRISTORS (ETO) by inventor(s) a. Huang described in

- (check one) ☒ the specification filed herewith.
- ☐ application Serial No. _____, filed _____
- ☐ Patent No. 5, _____ issued _____, 199 .

I hereby declare that rights under contract or law have been conveyed to and remain with the small business concern identified above with regard to the above identified invention.

If the rights held by the above identified nonprofit organization are not exclusive, each individual, concern or organization having rights to the invention is listed below* and no rights to the invention are held by any person, other than the inventor, who could not qualify as a small business concern under 37 C.F.R. §1.9(d) or by any concern which would not qualify as a small business concern under 37 C.F.R. §1.9(d) or a nonprofit organization under 37 C.F.R. §1.9(e). *NOTE: Separate verified statements are required from each named person, concern or organization having rights to the invention averring to their status as small entities. (37 C.F.R. §1.27)

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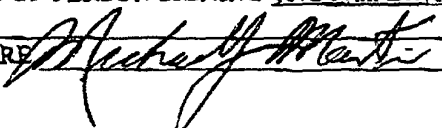
Docket No.: 96-037

NAME _____
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ADDRESS _____
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I acknowledge the duty to file, in this application or patent, notification of any change in status resulting in loss of entitlement to small entity status prior to paying, or at the time of paying, the earliest issue fee or any maintenance fee due after the date on which status as a small entity is no longer appropriate. (37 C.F.R. §1.28(b))

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements are made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under section 1001 of Title 18 of the United States Code, and that such willful false statements may jeopardize the validity of the application, any patent issuing thereon, or any patent to which this verified statement is directed.

NAME OF PERSON SIGNING Mr. Michael Martin
TITLE OF PERSON IN ORGANIZATION Executive Vice President
ADDRESS OF PERSON SIGNING 1872 Pratt Drive, Blacksburg, Virginia 24061
SIGNATURE  DATE 2/28/00

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EMITTER TURN-OFF THYRISTORS (ETO)

DESCRIPTION

5 BACKGROUND OF THE INVENTION

Field of the Invention

10 The present invention generally relates to a novel family of thyristors and, more particularly, to a family of low cost metal oxide semiconductor (MOS) emitter turn-off thyristors.

Description of the Prior Art

15 Thyristors, sometimes referred to as silicon controlled rectifiers, are four layer pnpn devices comprising an anode, a cathode, and a gate terminal. Thyristors are designed to carry very high currents with very little voltage drop. For example, at currents of up to 500 A, the voltage drop across the anode and cathode terminals typically does not exceed 2 V. This makes thyristors ideal for power electronics
20 switching applications such as converting one power form to another, such as, for example dc-ac or dc-dc.

Standard thyristors are turned on by applying a short current pulse across the cathode and gate terminals. Once the device is turned on, high currents may flow between the anode and cathode. Unfortunately, the gate can only be used to turn the
25 device on, it cannot be used to turn the device off. Turn-off is accomplished by applying a reverse voltage across the anode and the cathode. Several variations of the standard thyristor have been developed to facilitate the turn-off operation such as, for example, gate turn-off thyristors (GTO) and metal-oxide semiconductor (MOS)-controlled thyristors (MCTs).

30 Gate turn-off thyristors (GTO) have been developed which can turn the device off by applying a reverse gate pulse to bypass carriers directly to the gate

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circuit. However, GTO's are known to have a poor turn off current gain. For example, a GTO having a 2000 A peak current may require up to 500 A of reverse gate current.

The MOS-controlled thyristor (MCT) has been around for about a decade and is basically a thyristor including two built in MOS transistors, one to turn the thyristor on, and one to turn it off. The gates of the two MOS transistors are tied together. A relatively low negative voltage pulse (i.e., -7 V) to the gates turn the thyristor on, and a positive pulse (i.e., 14 V) to the gates turn the thyristor off. Hence, the MCT has the advantage of being able to be driven directly by logic gates. However, MCTs are typically expensive to fabricate and very difficult to scale to high voltage (e.g., >2KV) and high current (e.g., >100A).

SUMMARY OF THE INVENTION

It is therefore an object of the present invention to provide an improved family of emitter turn-off (ETO) thyristors which are suitable for operation in high frequency and which are inexpensive to fabricate.

It is yet another object of the present invention to provide an improved family of emitter turn-off thyristor (ETO) to replace the GTO, and an improved family of emitter-controlled thyristor (ECT) to replace MCT. ETO and ECT are based on the same operation principle of emitter control, but ETO is a hybrid device hence is inexpensive in fabrication, while the ECT is a monolithic device that requires standard power device fabrication process.

Disclosed herein is a family of emitter controlled thyristors (ECT) and emitter turn-off thyristors (EOT) employing a plurality of control schemes for turning the thyristor on and off. In a first embodiment of the present invention a family of thyristors are disclosed all of which comprise a pair of MOS transistors, the first of which is connected in series with the thyristor (hence after called emitter switch, or Q_E or Q_1) and a second which provides a connection from the thyristor gate to the cathode or ground (hence after called gate switch or Q_G or Q_2). A third optional MOSFET (hence after called Q_{on} or Q_3) is used to provide the turn-on

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mechanism for the thyristor. Depending on whether a n-channel or p-channel device is used for Q_E . A negative voltage applied to the gate of the first MOS causes the thyristor to turn on to conduct high currents. A zero to positive voltage applied to the first MOS gate causes the thyristor to turn off. A negative feedback mechanism also exist between the Q_E and Q_G at high currents that causes the ECT to operate at its breakover boundaries of the latching condition with the NPN transistor portion of the thyristor operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode current increase. ETO devices disclosed here also use at least two switches Q_G and Q_E to control the current. They also have the negative feedback mechanism that causes the current to saturate at high currents. In particular, ETO fabrication packages are also disclosed having packaged semiconductor devices controlling the thyristor.

BRIEF DESCRIPTION OF THE DRAWINGS

The foregoing and other objects, aspects and advantages will be better understood from the following detailed description of a preferred embodiment of the invention with reference to the drawings, in which:

Figures 1A and 1B are a cross sectional view and an equivalent circuit diagram, respectively, of an emitter controlled thyristor according to a first embodiment of the invention;

Figures 1C and 1D are a cross sectional view and an equivalent circuit diagram, respectively, of an emitter controlled thyristor similar to that of Figure 1A-B having an additional NMOS transistor connected across the thyristor for device turn-on;

Figures 2A and 2B are a cross-sectional view of the ECT with a turn-on cell (ECT-OC) and its circuit equivalent, respectively;

Figures 3A and 3B are a cross-sectional view of a lateral emitter controlled thyristor (LECT), respectively;

Figures 4A and 4B are a cross-sectional view of a lateral NMOS emitter controlled thyristor (LNECT) controlled thyristor and its circuit equivalent,

respectively;

Figures 5A and 5B are a cross-sectional view of a lateral emitter controlled thyristor (LECT) and its circuit equivalent, respectively;

5 Figures 6A and 6B are a cross-sectional view of an alternate embodiment of the ECT shown in Figures 1A-B with a metal connection and its circuit equivalent, respectively;

Figures 7A and 7B are a cross-sectional view of a single gate NMOS emitter controlled thyristor (SNECT) and its circuit equivalent, respectively;

10 Figures 8A and 8B are a cross-sectional view of a single gate emitter controlled thyristor (SECT) and its circuit equivalent;

Figures 9A and 9B are a cross-sectional view of an emitter turn off thyristor (ETO) and its circuit equivalent, respectively, according to a second embodiment of the present invention;

15 Figures 10A and 10B are a cross-sectional view of an alternate emitter turn off thyristor (ETO) and its equivalent circuit;

Figures 11A and 11B are a cross-sectional view of an alternate emitter turn off thyristor (ETO) and its circuit equivalent, respectively ;

Figures 12A and 12B are a cross-sectional view of an alternate emitter turn off thyristor (ETO) and its equivalent circuit, respectively;

20 Figures 13A and 13B are a cross-sectional view of an alternate emitter turn off thyristor (ETO) and its circuit equivalent, respectively;

Figures 14A and 14B are a cross-sectional view of an alternate emitter turn off thyristor (ETO) and its equivalent circuit, respectively;

25 Figures 15A and 15B are a cross-sectional view of a package that attaches to a MOSFET die on a single emitter finger of the GTO and its equivalent circuit, respectively, similar to that shown in Figure 9;

30 Figure 16A and 16B are a cross-sectional view of a package that attaches to a MOSFET die on multiple emitter fingers of the GTO and equivalent circuit, respectively, similar to that shown in Figure 9 but having multiple emitter fingers in the active area;

Figure 17A is cross sectional view of an ETO packaged by connections Q_G

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and Q_E externally;

Figures 17B-D are an equivalent circuit, top, and perspective view, respectively, of the ETO fabrication package shown in Figure 17A.

Figures 17E-F voltage-current turn-on and turn-off timing diagrams, respectively, for the ETO package shown in Figures 17A;

Figure 18 is a schematic showing connection of the ETO implemented in Figures 17A-D that provides a three terminal solution wherein a feedback network is implemented between the gate of Q_E and the drain of Q_E ; and

Figure 19 is a schematic showing a ETO connection as implemented in Figures 17A-D that provides a separate drive signal to Q_E and Q_G , and a capacitor C in parallel with Q_G .

DETAILED DESCRIPTION OF A PREFERRED EMBODIMENT OF THE INVENTION

Referring now to the drawings, and more particularly to Figures 1A and 1B, there is shown a cross-sectional view of the emitter controlled thyristor (ECT) and its equivalent circuit, respectively. The ECT has a four-layer PNP thyristor structure 2, in series with a P channel MOSFET (PMOS1) 10 integrated on the top N layer. In Figure 1B the PNP thyristor is shown as a PNP bipolar transistor 6 and NPN bipolar transistor 8. A Floating Ohmic Contact (FOC) 12 shorting the N emitter 14 and the P+ region 16 which acts as the source of the PMOS1 10. The FOC 12 provides the bridge for transferring emitter electron currents of the upper NPN transistor into hole currents, which then flow through the PMOS1 10 channel and into the cathode contact 18. A second PMOSFET (PMOS2) 20 is formed at the other side of the cathode contact with the upper P base 22 acting as the source. The PMOS2 does not have a separate control gate, instead, its gate 24 is tied to the cathode contact 18.

During the forward current conduction, a large negative gate voltage is applied to the main gate 26, the ECT current flows vertically along the PNP thyristor structure, and then laterally flows through the series PMOS1 and into the

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cathode 18. The ECT's forward voltage drop is therefore that of a thyristor plus that of the PMOS1 10.

With the increase of the current, the voltage of the FOC 12, V_{FOC} , will increase due to the channel resistance of the PMOS1 10. When $V_{FOC} > -V_{T2}$, where $V_{T2} < 0$ is the threshold voltage of the PMOS2 20, the PMOS2 20 turns "on", and hole currents will be diverted from the upper base through the PMOS2 20 into the cathode 18. The turn-on of the PMOS2 20 will reduce the upper NPN transistor's 6 current gain. If the reduction of the upper NPN transistor 6 current gain, $\Delta\alpha_{npn}$, cannot be compensated by an increase of the lower PNP transistor 8 current gain, $\Delta\alpha_{pnp}$, so that

$$\alpha_{npn} + \alpha_{pnp} - \Delta\alpha_{pnp} \leq 1 \quad (1)$$

then the ECT will come out of latching state. If this happens, the current flowing through the PMOS1 10 will tend to decrease, and so will the V_{FOC} . A reduced V_{FOC} means a reduction of the diverted current through the PMOS2 20 and the decrease of the $\Delta\alpha_{npn}$; hence, the ECT enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor 2 can only operate at the breakover boundaries of the latching condition with the NPN transistor 6 operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J3. The lower PNP transistor 8 (also operating in the active region) supplies base current for the upper NPN transistor 6, and the saturation current is the holding current of the thyristor with both PMOS1 10 and PMOS2 20 conducting. This phenomena is called high voltage current saturation or forward bias safe operation area (FBSOA). At very high voltages, the increase of α_{pnp} will compensate α_{npn} , and the ECT will tend to latch again until equation (1) is violated. The violation point can be considered to correspond to the ECT's FBSOA boundary point.

The ECT can be turned-off by increasing the gate electrode voltage to zero

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or positive value in the PMOS1 10, which interrupts the main current flow path. All currents are then forced to divert to the cathode by the PMOS2 20. Both emitter switch (PMOS1) and emitter short (PMOS2) are used in the turn-off of the ECT, and unlike in the EST, no parasitic thyristor limits the reverse bias safer operation area (RBSOA) of the ETC.

Figures 1C and 1D show an ECT and its schematic equivalent having MOS turn-on, and an emitter switch for MOS turn-off. As shown in Figure 1D, the thyristor of Figure 1C-D is similar to that shown in Figures 1A-B with the addition of an NMOS transistor 70. The additional NMOS 70 is designed to be a depletion MOSFET. The gate of it is also tied to ground. The leakage current of this MOSFET will turn-on the ECT when a negative gate voltage is applied to the main control gate, 26.

Referring now to Figures 2A there is shown a cross-sectional view of the ECT with a novel turn-on cell (ECT-OC) 30 and Figure 2B shows its circuit equivalent. The circuit is similar to the one shown in Figure 1 with the addition of an avalanche diode 30 connected between the gate 48 of the first PMOS and the thyristor. The ECT-OC has a 4-layer PNPN thyristor structure 2 in series with a P channel MOSFET (PMOS1) 32 integrated on the top N layer 34. A Floating Ohmic Contact (FOC) 36 shorting a P+ region 38 and the N emitter acts as the source of the PMOS1 32. The FOC 36 provides the bridge for transferring emitter electron currents of the upper NPN transistor 40 into hole currents, which then flow through the PMOS1 32 channel and into the cathode contact 42. A second PMOSFET (PMOS2) 44 is formed at the other side of the cathode contact 42 with the upper P base 46 acting as the source. The PMOS2 44 does not have a separate control gate, instead, its gate is tied to the cathode contact 42. A P+-N diode 46 forms the turn-on cell located in the top N region, and its P+ anode is tied to the gate electrode of the ECT-OC.

When a positive bias is applied to the anode and a negative gate voltage is applied to the gate electrode 48, the avalanche breakdown will be appeared at the P+-N junction of the turn-on cell 30. Electrons created by the avalanche breakdown will injected into the thyristor and trigger the thyristor into the latching state. The

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ECT-OC current flows vertically along the P+-N-P-N thyristor structure, and then laterally flows through the series PMOS1 32 and into the cathode 42. The ECT-OC's forward voltage drop is therefore that of a thyristor plus that of the PMOS1 32. With the increase of the current, the voltage of the FOC 36, V_{FOC} , will increase due to the channel resistance of the PMOS1 32. When $V_{FOC} > -V_{T2}$, where $V_{T2} < 0$ is the threshold voltage of the PMOS2 44, the PMOS2 44 turns 'on', and hole currents will be diverted from the upper base through the PMOS2 44 into the cathode 42. The turn-on of the PMOS2 44 will reduce the upper NPN transistor's current gain. If the reduction of the upper NPN transistor 40 current gain, $\Delta\alpha_{npn}$, cannot be compensated by an increase of the lower PNP 50 transistor current gain, $\Delta\alpha_{pnp}$, so that

$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (2)$$

then the ECT-OC will come out of latching state. If this happens, the current flowing through the PMOS1 32 will tend to decrease, and so will the V_{FOC} . A reduced V_{FOC} means a reduction of the diverted current through the PMOS2 44 and the decrease of the $\Delta\alpha_{npn}$, hence the ECT-OC enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at the breakover boundaries of the latching condition with the NPN transistor 40 operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J3. The lower PNP transistor 50 (also operating in the active region) supplies base current for the upper NPN transistor 40, and the saturation current is the holding current of the thyristor with both PMOS1 32 and PMOS2 44 conducting. At very high voltages, the increase of $\Delta\alpha_{pnp}$ will compensate $\Delta\alpha_{npn}$ and the ECT-OC will tend to latch again until equation (2) is violated. The violation point can be considered to correspond to the ECT-OC's FBSOA boundary point.

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The ECT-OC can be turned-off by increasing the gate electrode 48 voltage to zero or positive value in the PMOS1 32, which interrupts the main current flow path. All currents are then forced to divert to the cathode by the PMOS2 44. Both emitter switch (PMOS1) 32 and emitter short (PMOS2) 44 are used in the turn-off of the ECT, and unlike in the EST, no parasitic thyristor limits the RBSOA of the ECT-OC.

Figures 3A-B show lateral emitter controlled thyristor (LECT) cross-section and its equivalent circuit diagram, respectively on a silicon oxide SiO substrate. The LECT has a lateral 4-layer P⁺-N-P-N⁺ thyristor structure 2 in series with a P channel MOSFET (PMOS1) 60 integrated on the surface of the N layer through a Floating Ohmic Contact (FOC) metal strap 62. The FOC 62 connects the upper N⁺ emitter 64 of the PNP thyristor and the P⁺ source region 66 of the PMOS1 60. The FOC 62 provides the bridge for transferring emitter electron currents of the NPN transistor into hole currents, which then flow through the PMOS1 60 channel and into the cathode contact 68. An N-channel depletion mode MOSFET (NMOS) 70 is also integrated at the surface of the LECT which acts as the turn-On MOSFET. A second PMOSFET (PMOS2) 72 is formed between the P base 74 and the P⁺ drain 76 of the PMOS1 60 with the P base 74 acting as its source. The NMOS 70 and the PMOS2 72 share the same gate 78, and the gate is directly tied to the cathode contact 68, hence, the LECT is a three-terminal device.

When a positive bias is applied to the anode 80 and a negative gate voltage is applied to the gate electrode 78, the depletion mode NMOS 70 will inject electrons into the n-drift region of the thyristor and trigger the thyristor into the latching state. The latching current flows into the N⁺ emitter 64 of the thyristor and then flows into the cathode 68 through the FOC metal strap 62 and the series PMOS 1 60. The LECT's forward voltage drop is therefore that of a thyristor plus that of the PMOS1 60. With the increase of the current, the voltage at the FOC metal strap 62, V_m , will increase, the PMOS2 72 will be turned 'on' and hole currents will be diverted from the p base through the PMOS2 72 into the cathode 68. Consequently, the turn-on of the PMOS2 72 will reduce the NPN transistor's current gain. If the reduction of the NPN transistor current gain, $\Delta\alpha_{npn}$ cannot be compensated by an

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increase of the PNP transistor current gain, $\Delta\alpha_{npn}$ so that

$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (3)$$

then the LECT will come out of latching state. If this happens, the current flowing through the PMOS2 72 will tend to decrease, and so will the V_m . A reduced V_m means a reduction of the diverted current through the PMOS2 72 and the decrease of the $\Delta\alpha_{npn}$, hence the LECT enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at the breakover boundaries of the latching condition with the NPN transistor operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J2. and the LECT has a high voltage current saturation capability.

The LECT can be turned-off by increasing the gate electrode 78 voltage to zero or positive to turned 'off' the PMOS1 60, which interrupts the main current flow path, and all currents are then forced to divert to the cathode 68 by the PMOS2 72. Moreover, both emitter switch and emitter short are used in the turn-off of the LECT, no parasitic thyristor limits the Reverse Bias SCA (RBSCA) of the LECT.

Referring now to Figures 4A-B, there is shown a cross-sectional view of another lateral emitter controlled thyristor (LNECT) on the silicon oxide (SiO) substrate 90 and its equivalent circuit, respectively. The LNECT has a lateral 4-layer $P^+-N-P-N^+$ thyristor 2 structure in series with a N channel MOSFET (NMOS1) integrated on the surface of the P well through a Floating Ohmic Contact (FOC) metal strap. The FOC connects the upper N^+ emitter of the PNPN thyristor and the N^+ drain region of the NMOS1. An N-channel depletion mode MOSFET (NMOS2) is also integrated at the surface of the LNECT which acts as the turn-on

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MOSFET. A P-channel MOSFET (PMOS) is formed between the P base and the P well with the P base acting as its source. The cathode shorts the N⁺ source of the NMOS1 92 and the P well 94. The gate electrode 96 of the NMOS2 98 and the PMOS 100 is directly tied to the cathode contact 102; hence, the LNECT is a

5 three-terminal device.

When a positive bias is applied to the anode and the gate electrode 96, the depletion mode NMOS2 98 will inject electrons into the N-drift region of the thyristor and trigger the thyristor into the latching state. The latching current flows into the N⁺ emitter of the thyristor and then flows into the cathode 102 through the FOC metal strap 104 and the series NMOS1 92. The LNECT's forward voltage drop is therefore that of a thyristor plus that of the NMOS1 92. With the increase of the current, the voltage at the FOC metal strap 104, V_m , will increase, the PMOS 100 will be turned 'on' and hole currents will be diverted from the P base through the PMOS 100 into the cathode 102. Consequently, the turn-on of the PMOS 100 will reduce the NPN transistor's current gain. If the reduction of the NPN transistor current gain, $\Delta\alpha_{npn}$ cannot be compensated by an increase of the PNP transistor current gain, $\Delta\alpha_{pnp}$ so that

10

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$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (4)$$

20 then the LNECT will come out of latching state. If this happens, the current flowing through the PMOS 100 will tend to decrease, and so will the V_m . A reduced V_m means a reduction of the diverted current through the PMOS 100 and the decrease of the $\Delta\alpha_{npn}$ hence the LNBCT enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at

25 the breakover boundaries of the latching condition with the NPN transistor operating in the active region. Under this condition, the anode 106 voltage V_A continues to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J2. and the LNECT has a high

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voltage current saturation capability.

The LNECT can be turned-off by decreasing the gate electrode 108 voltage to zero or negative to turned 'off' the NMOS1 92, which interrupts the main current flow path, and all currents are then forced to divert to the cathode by the PMOS 100. Moreover, both emitter switch and emitter short are used in the turn-off of the LNECT, no parasitic thyristor limits the Reverse Bias SOA (RBSOA) of the LNECT.

Referring now to Figures 5A-B, there is shown a cross-sectional view of the another variation of the LECT (LECT-1) and its equivalent circuit, respectively.

The LECT-1 has a lateral 4-layer P⁺-N-P-N⁺ thyristor structure 2, in series with a P channel MOSFET (PMOS1) 110 integrated on the surface of the N layer through a Floating Ohmic Contact (FOC) metal strap 112. The FOC 112 connects the upper N⁺ emitter 114 of the PNP thyristor and the P+ source region 116 of the PMOS1 110. The FOC 112 provides the bridge for transferring emitter electron currents of the NPN transistor into hole currents, which then flow through the PMOS1 110 channel and into the cathode contact 116. An N-channel depletion mode MOSFET (NMOS) 118 is also integrated at the surface of the LECT-1 which acts as the turn-on MOSFET. A second PMOSFET (PMOS2) 120 is formed between the P base and the P drain of the PMOS1 110 with the P base acting as its source. The NMOS 118 and the PMOS2 120 share the same gate 122, and the gate is directly tied to the cathode contact 116, hence, the LECT-1 is a three-terminal device.

When a positive bias is applied to the anode 124 and a negative gate voltage is applied to the gate electrode 126, the depletion mode NMOS 118 will inject electrons into the n-drift region of the thyristor and trigger the thyristor into the latching state. The latching current flows into the N⁺ emitter of the thyristor and then flows into the cathode 116 through the FOC metal strap 112 and the series PMOS1 110. The LECT-1's forward voltage drop is therefore that of a thyristor plus that of the PMOS1 110. With the increase of the current, the voltage at the FOC metal strap 112, V_m , will increase, the PMOS2 120 will be turned 'on' and hole currents will be diverted from the P base through the PMOS2 120 into the cathode 116. Consequently, the turn-on of the PMOS2 120 will reduce the NPN

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transistor's current gain. If the reduction of the NPN transistor current gain, $\Delta\alpha_{npn}$, cannot be compensated by an increase of the PNP transistor current gain, $\Delta\alpha_{pnp}$ so that

$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (5)$$

then the LECT-1 will come out of latching state. If this happens, the current flowing through the PMOS2 120 will tend to decrease, and so will the V_m . A reduced V_m means a reduction of the diverted current through the PMOS2 120 and the decrease of the $\Delta\alpha_{pnp}$, hence, the LECT-1 enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at the breakover boundaries of the latching condition with the NPN transistor operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J2. and the LECT-1 has a high voltage current saturation capability.

The LECT-1 can be turned-off by increasing the gate electrode 126 voltage to zero or positive to turned 'off' the PMOS1 110, which interrupts the main current flow path, and all currents are then forced to divert to the cathode 116 by the PMOS2 120. Moreover, both emitter switch and emitter short are used in the turn-off of the LECT-1, no parasitic thyristor limits the Reverse Bias SOA (RBSOA) of the LECT-1.

Referring now to Figures 6A-6B, there is shown a cross sectional view of a emitter controlled thyristor with a metal connection (ECT-MC) and its equivalent circuit, respectively. The ECT-MC has a 4-layer $P^+ - N - P - N^+$ thyristor structure 2 in series with a P channel MOSFET (PMOS1) 130 integrated on the top N layer through a metal strap 132. This metal strap 132 shorting the N^+ emitter 134 and the P^+ region 136 which acts as the source of the PMOS1 130. And the metal strap 132 provides the bridge for transferring emitter electron currents of the upper NPN transistor into hole currents, which then flow through the PMOS1 130 channel and

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into the cathode contact 138. A second PMOSFET (PMOS2) 140 is formed at the other side of the cathode contact 138 with the upper P base acting as the source. The PMOS2 140 does not have a separate control gate, instead, its gate 142 is tied to the cathode contact 138.

5 The operation mechanism of the ECT with a metal-connection 132 is similar as that of the ETC. During the forward current conduction, a large negative gate voltage is applied to the main gate 144, the ECT-MC current flows vertically along the PNP thyristor structure, and then laterally flows through the series PMOS1 130 and into the cathode 138. The ECT-MC's forward voltage drop is therefore that of a thyristor plus that of the PMOS1 130. With the increase of the current, the voltage of the metal strap 132, V_m , will increase due to the channel resistance of the PMOS1 130. When $V_m > -V_{T2}$, where $V_{T2} < 0$ is the threshold voltage of the PMOS2 140, the PMOS2 140 turns 'on', and hole currents will be diverted from the upper base through the PMOS2 140 into the cathode 138. The turn-on of the PMOS2 140 will reduce the upper NPN transistor's current gain. If the reduction of the upper NPN transistor current gain, $\Delta\alpha_{npn}$, cannot be compensated by an increase of the lower PNP transistor current gain, $\Delta\alpha_{pnp}$ so that

$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (6)$$

20 then the ECT-MC will come out of latching state. If this happens, the current flowing through the PMOS1 130 will tend to decrease, and so will the V_m . A reduced V_m means a reduction of the diverted current through the PMOS2 140 and the decrease of the $\Delta\alpha_{npn}$ hence the ECT-MC enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at the breakover boundaries of the latching condition with the NPN transistor operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode 146 current increase, and the increased anode voltage is supported by the main junction J3. The lower PNP

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transistor (also operating in the active region) supplies base current for the upper NPN transistor, and the saturation current is the holding current of the thyristor with both PMOS1 130 and PMOS2 140 conducting. At very high voltages, the increase of $\Delta\alpha_{npn}$ will compensate $\Delta\alpha_{pnp}$, and the ECT-MC will tend to latch again until equation (6) is violated. The violation point can be considered to correspond to the ECT-MC's FBSOA boundary point.

The ECT-MC can be turned-off by increasing the gate electrode voltage to zero or positive value in the PMOS1 130, which interrupts the main current flow path. All currents are then forced to divert to the cathode by the PMOS2 140. Both emitter switch (PMOS1) 130 and emitter short (PMOS2) 140 are used in the turn-off of the ECT-MC, and unlike in the EST, no parasitic thyristor limits the RBSOA of the ECT-MC.

Referring now to Figures 7A-B, there is shown a cross-sectional view of the Single Gate NMOS ECT (SNECT) and its equivalent circuit, respectively. The SNECT has a 4-layer PNP thyristor structure 2 in series with a N channel MOSFET (NMOS1) 150 integrated on the top of the P well through a Floating Ohmic Contact (FOC) metal strap 152. The FOC 152 connects the upper N+ emitter 154 of the PNP thyristor and the N+ drain region 156 of the NMOS1. An N-channel depletion mode MOSFET (NMOS2) 158 is also integrated at the surface of the SNECT which acts as the turn-on MOSFET. A P-channel MOSFET (PMOS) 160 is formed between two P regions. The NMOS2 162 and the PMOS 160 share the same gate 164, and the gate is directly tied to the cathode contact 166; hence, the SNECT is a three-terminal device.

When a positive bias is applied to the anode 168 and a positive gate voltage is applied to the gate electrode 170, the depletion mode NMOS1 150 will inject electrons into the n-drift region of the thyristor and trigger the thyristor into the latching state. The latching current flows into the upper N emitter 172 of the thyristor and then flows laterally into the cathode through the FOC metal strap 152 and the series NMOS1 150. The SNECT's forward voltage drop is therefore that of a thyristor plus that of the PMOS 160. With the increase of the current, the voltage at the FOC metal strap 152, V_m , will increase, the PMOS 160 will be turned 'on'

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and hole currents will be diverted from the upper base of the NPN transistor through the PMOS 160 into the cathode 166. Consequently, the turn-on of the PMOS 160 will reduce the upper NPN transistor's current gain. If the reduction of the upper NPN transistor current gain, $\Delta\alpha_{npn}$, cannot be compensated by an increase of the lower PNP transistor current gain, $\Delta\alpha_{pnp}$, so that

$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (7)$$

then the SNECT will come out of latching state. If this happens, the current flowing through the PMOS 160 will tend to decrease, and so will the V_m . A reduced V_m means a reduction of the diverted current through the PMOS 160 and the decrease of the $\Delta\alpha_{npn}$ hence, the SNECT enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at the breakover boundaries of the latching condition with the NPN transistor operating in the active region. Under this condition, the anode voltage V_A continues to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J2. and the SNECT has a high voltage current saturation capability.

The SNECT can be turned-off by decreasing the gate electrode 170 voltage to zero or negative to turned 'off' the NMOS1 150, which interrupts the main current flow path, and all currents are then forced to divert to the cathode 166 by the PMOS 160. Moreover, both emitter switch and emitter short are used in the turn-off of the SNECT, no parasitic thyristor limits the Reverse Bias SOA (RBSOA) of the SNECT.

Referring now to Figures 8A-B, there is shown a cross-sectional view of a single gate emitter controlled thyristor SECT and its circuit equivalent, respectively. The SECT has a 4-layer PNPN thyristor structure 2 in series with a P channel MOSFET (PMOS1) 180 integrated on the surface of the N substrate through a Floating Ohmic Contact (FOC) metal strap 182. The FOC 182 connects the upper N^+ emitter 184 of the PNPN thyristor and the P source region 186 of the PMOS1

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180. The FOC 182 provides the bridge for transferring emitter electron currents of the upper NPN transistor into hole currents, which then flow through the PMOS1 180 channel and into the cathode contact. An N-channel depletion mode MOSFET (NMOS) 188 is also integrated at the surface of the SECT which acts as the turn-on MOSFET. A second PMOSFET (PMOS2) 190 is formed between the turn-on NMOS 188 and the PMOS1 180 with the upper P base acting as its source. The NMOS 188 and the PMOS2 190 share the same gate 196, and the gate is directly tied to the cathode contact 192, hence, the SECT is a three-terminal device.

When a positive bias is applied to the anode 194 and a negative gate voltage is applied to the gate electrode 196, the depletion mode NMOS will inject electrons into the n-drift region of the thyristor and trigger the thyristor into the latching state. The latching current flows into the upper N emitter of the thyristor and then flows laterally into the cathode through the FOC metal strap 182 and the series PMOS1 180. The SECT's forward voltage drop is therefore that of a thyristor plus that of the PMOS1 180. With the increase of the current, the voltage at the FOC metal strap 182, V_m , will increase, the PMOS2 190 will be turned 'on' and hole currents will be diverted from the upper base through the PMOS2 190 into the cathode 192. Consequently, the turn-on of the PMOS2 190 will reduce the upper NPN transistor's current gain. If the reduction of the upper NPN transistor current gain, $\Delta\alpha_{npn}$ cannot be compensated by an increase of the lower PNP transistor current gain, $\Delta\alpha_{pnp}$, so that

$$\alpha_{npn0} + \alpha_{pnp0} - \Delta\alpha_{npn} + \Delta\alpha_{pnp} \leq 1 \quad (8)$$

then the SECT will come out of latching state. If this happens, the current flowing through the PMOS2 190 will tend to decrease, and so will the V_m . A reduced V_m means a reduction of the diverted current through the PMOS2 190 and the decrease of the $\Delta\alpha_{npn}$ hence the SECT enters latching again. Such negative feedback mechanism, therefore, leads to the fact that the main thyristor can only operate at the breakover boundaries of the latching condition with the NPN transistor operating in the active region. Under this condition, the anode voltage V_A continues

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to increase without significant anode current increase, and the increased anode voltage is supported by the main junction J2. and the SECT has a high voltage current saturation capability.

The SECT can be turned-off by increasing the gate electrode voltage to zero or positive to turned 'off' the PMOS1 180, which interrupts the main current flow path, and all currents are then forced to divert to the cathode 182 by the PMOS2 190. Moreover, both emitter switch and emitter short are used in the turn-off of the SECT, no parasitic thyristor limits the Reverse Bias SOA (RBSOA) of the SECT.

Referring now to Figures 9A and 9B there is shown a cross-sectional view of an emitter turn off thyristor (ETO) and its equivalent circuit, respectively. The ETO comprises a PNP thyristor 202 and an emitter switch 200. MOSFETs or other MOS gated devices are used to build the emitter switch 200. The thyristor 202 can be a GTO or SCR device. The specially selected MOS gated device have their minimum forward voltage at high current. To turn off the thyristor 202, simply turn-off the emitter-devices by dropping the voltage at the gate 204 to zero. As shown by the arrows, in order to turn the thyristor on, the MOS switch 200 turns on and the thyristor gate injects current. In order to turn the thyristor off, MOS switch 204 is turned off and the thyristor gate B drains current.

Referring now to Figures 10A and B there is shown a cross-sectional view of an improved emitter turn off thyristor (ETO) and its equivalent circuit, respectively. The circuit is similar to the one shown in Figures 9A-B with the addition of a diode 206 connected between the thyristor gate B and the cathode terminal. The threshold voltage of the diode 206 selected is higher than the voltage drop across the thyristor gate to cathode plus the voltage of the emitter-switch 200 in an on-state. When the thyristor 202 is going to be turned on or in on state, the thyristor gate B voltage is always lower than that of the gate switch's 204 threshold voltage, the gate-switch 204 acts as open circuit. During the turn-off transient process, the emitter-switch 200 is off and can not conduct current. The diode 206 provides a path for the anode current to flow at turn-off and terminal B can be an open circuit.

Referring now to Figures 11A and 11B, there is shown a cross-sectional view of an emitter turn off thyristor (ETO) and its equivalent circuit. The circuit is

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similar to that shown in Figures 10A-B with the addition of a capacitor 210 connected in parallel to the diode 206. The capacitor 210 is used to help turn on the thyristor 202 by providing an alternative turn-on current for the thyristor gate B as shown by the arrow 214. The voltage of the capacitor 210 is clamped to the threshold voltage of the diode 206. To turn-on the ETO, the emitter-switch 200 is turned on and the capacitor 210 discharges through the thyristors gate-cathode and emitter-switch path. The discharge current acts as the turn on current for the thyristor 202. The capacitor 210 is charged during the turn-off transient when the anode current flows out of the thyristor gate B as shown by the arrow 216. With the structure describe above, the thyristor 202 is fully a MOS controlled device. It is turned on by adding a voltage on the MOS emitter-switch MOS gate 212. It is turned off by removing that voltage.

Referring now to Figures 12A and 12B there is shown a cross-sectional view of an improved emitter turn off thyristor (ETO) and its circuit equivalent, respectively. This circuit is similar to the one described with reference to Figures 11A-B, above, with the diode 206 being replaced with a Zener diode 220. Zener diodes are easier to achieve higher turn-on voltage than a diode; hence more energy can be stored. To turn on the thyristor, the MOS emitter switch 200 is turned on and the capacitor 210 injects current into the thyristor gate B as shown by arrow 214. For turn-off, the MOS emitter switch 200 is turned off and the Zener diode 220 drains current to charge the capacitor 210 as shown by arrow 216.

Referring now to Figures 13A and 13B there is shown a cross-sectional view of an emitter turn off thyristor (ETO) and its equivalent circuit, respectively. In this structure, two N-channel MOSFETs 200 and 224, one for the emitter switch and one for the gate switch, are used. The NMOS 224 has its drain and gate terminals connected together and can functions as the Zener diode discussed above but can handle higher currents. As before, for to turn on the thyristor, the MOS emitter switch 200 is turned on and the capacitor 210 injects current into the thyristor gate B as shown by arrow 214. For turn-off, the MOS emitter switch 200 is turned off the NMOS 224 drains current to charge the capacitor 210 as shown by arrow 216.

Referring now to Figures 14A and 14B, there is shown an emitter turn off

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thyristor (ETO) and its equivalent. This circuit is similar to the circuit shown above with reference to Figures 13A-B excepts the NMOS transistors are replaced with PMOS transistors 234 and 236. The PMOS 236 has its gate and drain terminals tied together. Compared to that of NMOS transistors, the PMOS transistors 234 and 236 drain is connected directly to the cathode terminal.

Referring now to Figures 15A and 15B there is shown a cross-sectional view of an emitter turn-off thyristor that attach a MOSFET die on a single emitter finger of the thyristor or GTO, and its equivalent circuit, respectively. To realize this ETO thyristor, the emitter-switch along with the gate-switch is packaged along with a gate-turn off thyristor (GTO) 302. As shown, an N-MOSFET die 300, acting as the emitter switch, is mounted on the cathode K of the GTO's die 302. The drain 304 of the NMOS device contacts directly with the cathode 306 of the GTO 302 with a metal strip 308. The source of the NMOS device becomes the cathode K of the ETO. By mounting the emitter-switch onto the GTO in the die form, the size of the ETO is minimized. Further, stray inductance between their connection is minimized.

Referring now to Figures 16A and 16B there is shown a cross-sectional view of an ETO that attaches a multiple die form MOSFET on multiple emitter fingers and its circuit equivalent, respectively. In this structure, both the N-MOS devices 300 and the GTO 302 are in die form. They do not contact each other directly but with a metal strip 308 between them. The metal strip 308 is put on the GTO's cathode, covering several cathode (emitter) fingers 310. In this form, the dimension of the GTO's cathode finger is not critical for the die form mounting. The cathode finger 310 can be as thin as possible and the MOS die can be as large as possible. On the other hand, the metal strip 308 supplies a path for horizontal current. So the MOS die is not needed to cover the whole GTO's cathode. Their number is only determined by the current capability but not their size.

Referring now to Figures 17A-D there is shown various views of a schematic ETO fabrication package. In this structure, all the components are used in their packaged forms. The packaged GTO 400 is put in the center of a round metal layer (copper layer 2) 403 which contacts the GTO's cathode. An N-MOSFET Q1

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used to build the emitter-switch is put on the metal layer around the GTO 400, and a P-MOSFET Q2 is also put on the metal layer 403 around the GTO 400. In the preferred embodiment, Q1 comprises a plurality of N-MOSFETs connected in parallel around the GTO 400. The various connections can be made on board 406.

5 Similarly, the emitter switch Q2 may comprise a plurality P-MOSFETs connected in parallel around the GTO 400. In addition, the emitter switch Q2 is not limited to P-MOSFETS, but may be any switching mechanism such as those described in Figures 9-14. Another metal layer (copper layer 3) 403 is put on the second metal layer 402 and acts as the ETO cathode. An insulation layer 405 electrically insulates the metal layers, 402 and 403. A top metal layer (copper layer 1) 401 is put on the anode of the GTO 400 and fasteners such as clamps or screws 404 are used to hold the structure together. Alternately, the device may simply be soldered together. The top metal layer 401 provides an additional means for dissipating heat but is not necessary for operation of the device. A positive voltage applied to the gate of the G1 of the first N-MOSFET Q1, and a current injected to terminal B turns the thyristor 400 on causing a current to flow between said anode and cathode terminals. A zero to negative voltage applied to the gate of Q1 turns the thyristor device to an off state stopping the current flow. During the turn-off, the cathode current is interrupted and is forced to transfer to the gate path, passing through the gate switch Q2 connected as a Zener diode. The ETO implemented this way is a four terminal device, providing MOS turn-off, and conventional turn-on through terminal B. Because the thyristor is sandwiched between metal plates, it has double side cooling for superior heat dissipation. In addition, since the GTO control devices Q1 and Q2 are arranged in a circular path around the GTO 400, the parasitic inductance in the current path between the anode and cathode is greatly reduced. Q1 and Q2 may be arranged in a single circle around the GTO 400 or may be arranged in two or more concentric circles around the GTO 400.

Figure 17E shows the turn-on timing diagram for the ETO package wherein the voltage drop across the anode and cathode drops from 2000V to near 0V in about 6 μ s and the current conducted between the anode and cathode goes from 0A to about 1000A in 25 μ s. Similarly, Figure 17F shows the turn-off timing diagram

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for the ETO package wherein the current flow between the anode and cathode is turned off in about 2 μ s.

Referring now to Figure 18, there is shown a different kind of connection that can be implemented in the ETO. By adding several components, a three
5 terminal device can be obtained where both the turn-on and turn-off is controlled by one single gate, G. A negative feedback network, 500, is also implemented to control the maximum voltage on emitter switch Q1 during the turn-off of that switch. An optional capacitance C 600, is in parallel with gate switch Q2 to provide additional turn-on current. This cap is able to deliver additional turn-on current
10 because it will store energy in a previous turn-off transient. The amount of energy is proportional to the square of the voltage on the gate switch Q2 that acts like a Zener diode, This ETO turns on when a positive voltage is added to gate and it turns off when that voltage is reduced to zero or negative.

Referring now to Figure 19, this circuit can also be implemented in the ETO
15 and is similar to that shown in Figure 18. The difference is that a separate control is added to gate switch Q2. The advantage of adding a control is that instead of having the gate switch Q2 operating like a Zener diode, hence very high power dissipation, the gate switch Q2 can operate in its linear region to reduce the impedance and thermal dissipation. The gate switch Q2 is only needed to be 'on' during the initial
20 stage of the device turn-off when a very high anode to gate Current exists. After the passing of that high anode-to-gate current, gate switch Q2 can be turned off, allowing the anode to gate tail current to charge the capacitor.

While the invention has been described in terms of preferred embodiments,
those skilled in the art will recognize that the invention can be practiced with
25 modification within the spirit and scope of the appended claims.

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Claims

I claim:

- 1 1. An emitter controlled thyristor device having a cathode terminal and an
2 anode terminal, comprising:
3 a thyristor device having a thyristor emitter, a thyristor collector, and
4 a thyristor gate, said thyristor comprising alternating P-type and N-type
5 semiconductor regions;
6 a first metal oxide semiconductor transistor (MOS) connected in
7 series with said thyristor between said cathode terminal said thyristor
8 emitter, said first MOS transistor integrated in at least one of the
9 semiconductor regions of said thyristor; and
10 a second MOS transistor integrated in at least one of said
11 semiconductor regions connected between said cathode terminal and said
12 thyristor gate, a gate terminal of said second MOS transistor connected to
13 said cathode terminal,
14 wherein a first voltage applied to a gate terminal of said first MOS
15 transistor causes a forward current to flow between said cathode terminal and
16 said anode terminal turning said emitter controlled thyristor device to an on
17 state, and a zero to second voltage turns applied to said gate of said first
18 MOS transistor turns said emitter controlled thyristor device to an off state.
- 1 2. An emitter controlled thyristor device as recited in claim 1 further
2 comprises a floating ohmic contact (FOC) for shorting said emitter and a
3 source terminal of said first MOS transistor.
- 1 3. An emitter controlled thyristor device as recited in claim 1 further
2 comprises a metal strap for shorting said thyristor emitter and a source
3 terminal of said first MOS transistor.
- 1 4. An emitter controlled thyristor device as recited in claim 1, further

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2 comprising:

3 a third MOS transistor having a source and a drain connected
4 between thyristor emitter and a thyristor lower base region, and a gate
5 connected to said cathode terminal.

1 5. An emitter controlled thyristor device as recited in claim 1 wherein said
2 first MOS transistor comprises a PMOS transistor, and said second MOS
3 transistor comprises a PMOS transistor.

1 6. An emitter controlled thyristor device as recited in claim 4 wherein said
2 first MOS transistor comprises a PMOS transistor, said second MOS
3 transistor comprises a PMOS transistor, and said third MOS transistor
4 comprises an NMOS transistor.

1 7. An emitter controlled thyristor device as recited in claim 4 wherein said
2 first MOS transistor comprises a NMOS transistor, said second MOS
3 transistor comprises a PMOS transistor, and said third MOS transistor
4 comprises an NMOS transistor.

1 8. An emitter controlled thyristor device as recited in claim 4 further
2 comprising a metal strap for shorting said thyristor emitter with one of a
3 drain and source terminal of said first MOS transistor.

1 9. An emitter controlled thyristor device as recited in claim 1, further
2 comprising a diode connected between said gate of said first MOS and said
3 thyristor emitter.

1 10. An emitter turn-off thyristor (ETO) device for carrying current between
2 a cathode terminal and an anode terminal, comprising:
3 a thyristor having a thyristor emitter, a thyristor collector connected
4 to said anode terminal, and a thyristor gate; and

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5 a packaged metal oxide semiconductor (MOS) transistor connected
6 between said thyristor emitter and said cathode terminal, wherein said
7 thyristor is turned on to conduct current between said cathode and said anode
8 terminal by applying a first voltage to a gate of said MOS transistor and
9 turned off by applying a second voltage to said gate of said MOS transistor.

1 11. An emitter turn-off thyristor (ETO) device as recited in claim 10 further
2 comprising:

3 a diode connected between said thyristor gate and said cathode
4 terminal, wherein a threshold voltage of the diode is higher than a voltage
5 drop across the thyristor gate to cathode plus a voltage drop across said MOS
6 transistor in an on-state.

1 12. An emitter turn-off thyristor (ETO) device as recited in claim 11, further
2 comprising:

3 a charge storage device connected in parallel with said diode, said
4 charge storage device providing a turn-on current for said thyristor gate.

1 13. An emitter turn-off thyristor (ETO) device as recited in claim 12
2 wherein said diode comprises at least one Zener diode.

1 14. An emitter turn-off thyristor (ETO) device for carrying current between
2 a cathode terminal and an anode terminal, comprising:

3 a thyristor having a thyristor emitter, a thyristor collector connected
4 to said anode terminal, and a thyristor gate;

5 a first metal oxide semiconductor (MOS) transistor connected
6 between said thyristor emitter and said cathode terminal;

7 a charge storage device connected between said thyristor gate and
8 said cathode terminal; and

9 a second MOS transistor connected in parallel with said charge
10 storage device, wherein said thyristor is turned on to conduct current

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11 between said cathode and said anode terminal by applying a first voltage to a
12 gate of said first MOS transistor and turned of by applying a second voltage
13 to said gate of said first MOS transistor.

1 15. An emitter turn-off thyristor (ETO) device as recited in claim 14
2 wherein said second MOS transistor is a PMOS transistor having its gate
3 terminal and drain terminal connected together to said cathode terminal.

1 16. An emitter turn-off thyristor (ETO) device as recited in claim 14
2 wherein said second MOS transistor is a NMOS transistor having its gate
3 terminal and source terminal connected together.

1 17. An emitter turn-off thyristor (ETO) device package comprising:
2 a first die comprising a gate-turn off thyristor (GTO), said first die
3 having an anode terminal, a thyristor gate, and at least one emitter finger;
4 and
5 at least one second die comprising a metal oxide semiconductor
6 (MOS) transistor connected in series with said first die, a first terminal of
7 said MOS transistor contacting at least one said emitter finger, and a second
8 terminal of said MOS transistor acting as a cathode terminal,
9 wherein a first voltage to a gate of said MOS transistor turns said
10 thyristor on passing current between said cathode terminal and said anode
11 terminal, and a second voltage to a gate of said MOS transistor turns said
12 thyristor off.

1 18. An emitter turn-off thyristor (ETO) device package as recited in claim
2 17, further comprising:
3 a plurality of said emitter fingers on a surface of said first die;
4 a plurality of said second die, each comprising a MOS transistor
5 connected in series with said first die on one of said plurality of emitter
6 fingers; and

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7 a metal strip sandwiched between each of said plurality of emitter
8 fingers and each of said plurality of second die.

1 19. An gate turn-off (GTO) thyristor device package comprising:
2 a first metal plate;
3 a second metal plate;
4 a third metal plate electrically insulated from said second metal layer;
5 a thyristor sandwiched between said first metal plate and said second
6 metal plate, a collector of said thyristor contacting said first metal plate
7 acting as an anode for said ETO device package;
8 a first metal oxide semiconductor (MOS) transistor positioned on said
9 second metal plate adjacent said thyristor, said first MOS transistor having a
10 first terminal connected to an emitter of said thyristor and a second terminal
11 connected to said third metal plate acting as a cathode for said ETO device
12 package; and
13 a second MOS transistor positioned on said second metal plate
14 adjacent said thyristor, said second MOS transistor having a first terminal
15 connected to a gate of said thyristor, said second MOS transistor further
16 having a second terminal and a gate terminal connected to said third metal
17 plate,
18 wherein a first voltage applied to a gate terminal of said first MOS
19 transistor turns said thyristor to an on state causing a current to flow between
20 said cathode and said anode, and a zero to second voltage applied to said
21 gate of said first MOS transistor turns said emitter controlled thyristor device
22 to an off state.

1 20. An gate turn-off (GTO) thyristor device package as recited in claim 19,
2 further comprising a clamp means for holding said first, second and third
3 metal layers together.

1 21. An gate turn-off (GTO) thyristor device package as recited in claim 19

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2 wherein said first, second, and third metal plates comprise copper plates.

1 22. An gate turn-off (GTO) thyristor device package as recited in claim 19
2 wherein said first MOS transistor and said second MOS transistor are
3 complementary.

1 23. An gate turn-off thyristor (GTO) device package comprising:
2 a gate turn-off (GTO) thyristor comprising a thyristor gate, a
3 thyristor emitter, and a thyristor collector forming an anode terminal;
4 a plurality of MOS transistors connected in parallel arranged in a
5 circular fashion around said GTO thyristor, a first terminal of said MOS
6 transistors connected to said thyristor emitter and a second terminal of said
7 MOS transistors connected to a cathode terminal of said GTO device
8 package; and
9 a plurality of MOS switching devices connected in parallel arranged
10 in a circular fashion around said GTO thyristor, a first terminal of said MOS
11 switching devices connected to said thyristor gate and a second terminal of
12 said MOS switching devices connected to said cathode terminal of said GTO
13 device package,
14 wherein a first voltage applied to a gate terminal of said MOS
15 transistors turns said GTO thyristor to an on state causing a current to flow
16 between said cathode terminal and said anode terminal, and a zero to second
17 voltage applied to said gate of said MOS transistors turns said GTO thyristor
18 to an off state.

1 24. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 further comprising:
3 a first metal plate forming said cathode terminal;
4 a second metal plate separated from said first metal plate by an
5 insulation layer, wherein said GTO thyristor and said MOS transistors and
6 said MOS switching devices are positioned on said second metal plate, said

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7 first and second metal plates acting a heat sink.

1 25. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 further comprising a third metal plate on top of said GTO thyristor forming
3 said anode terminal.

1 26. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 wherein said MOS switching devices comprise a MOSFET transistor having
3 a gate connected to said cathode terminal.

1 27. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 wherein said MOS switching devices comprise a diode.

1 28. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 wherein said MOS switching devices comprise a diode connected in parallel
3 with a capacitor.

1 29. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 wherein said MOS switching devices comprise a Zener diode connected in
3 parallel with a capacitor.

1 30. An gate turn-off thyristor (GTO) device package as recited in claim 23
2 wherein said MOS switching devices comprise a transistor connected in
3 parallel with a capacitor.

1 31. An gate turn-off thyristor (GTO) device package as recited in claim 26
2 further comprising;

3 a first feedback path connecting said gate terminal of said MOS
4 transistors to said thyristor emitter; and

5 a second feedback path connecting said gate terminal of said MOS
6 transistors to said thyristor gate terminal through a diode.

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- 1 32. A gate turn-off thyristor (GTO) device package as recited in claim 23
2 further wherein said MOS switching device comprises a MOS transistor
3 comprising;
4 a feedback path connecting said gate terminal of said MOS transistors
5 to said thyristor emitter;
6 a capacitor connected in parallel to said second feedback path
7 connecting said gate terminal of said MOS transistors to said thyristor gate
8 terminal through a diode.

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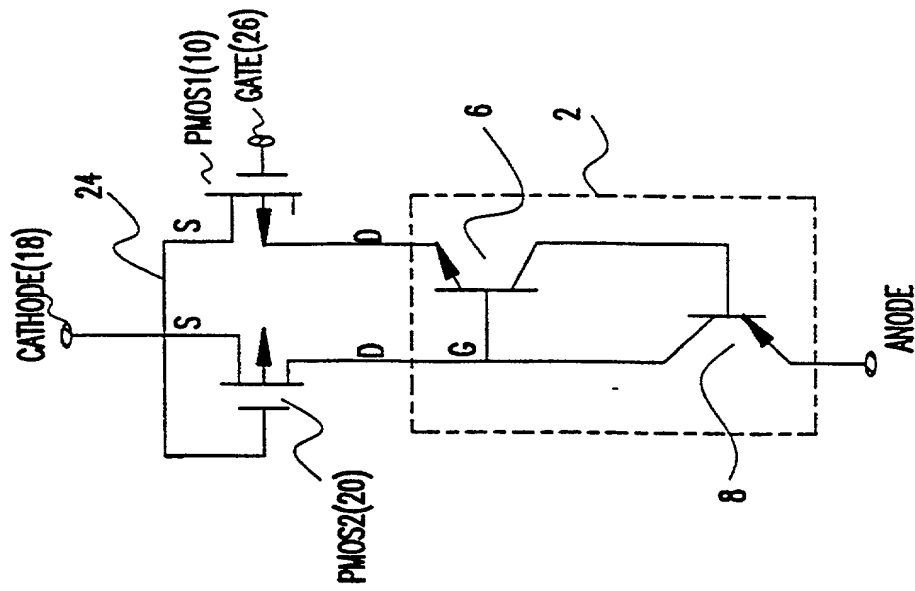


FIG. 1B

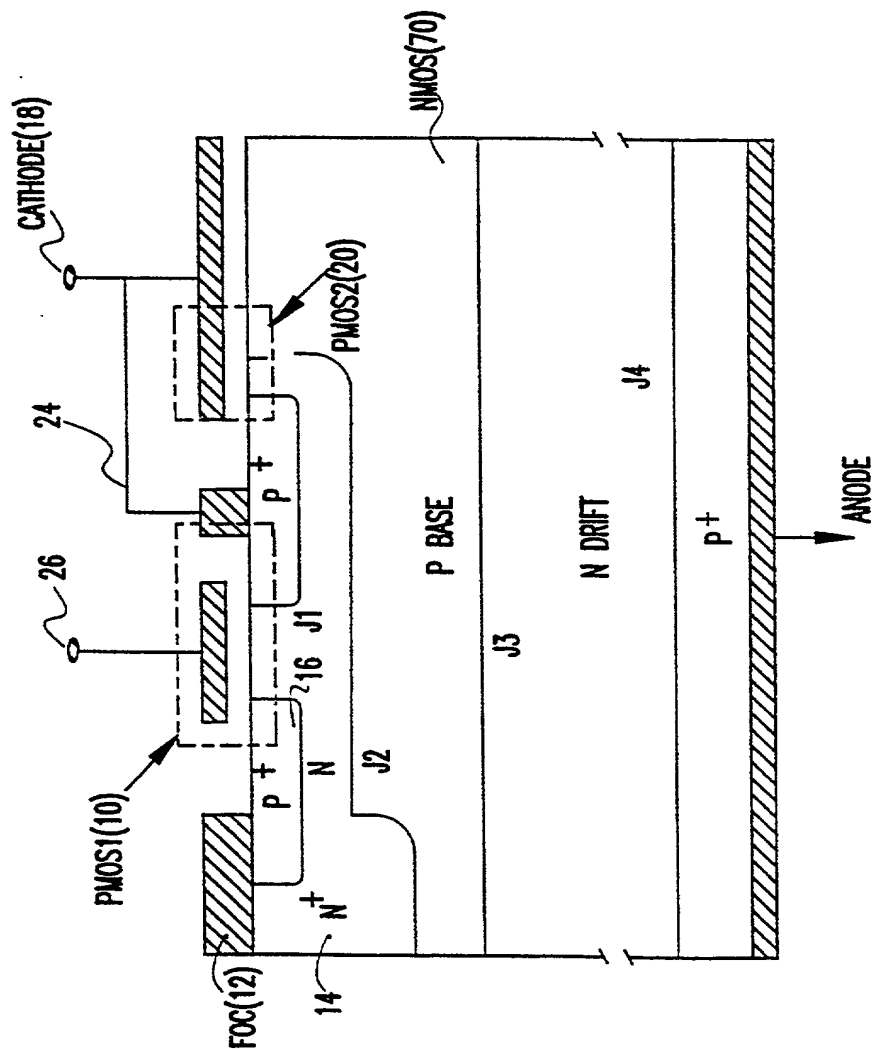


FIG. 1A

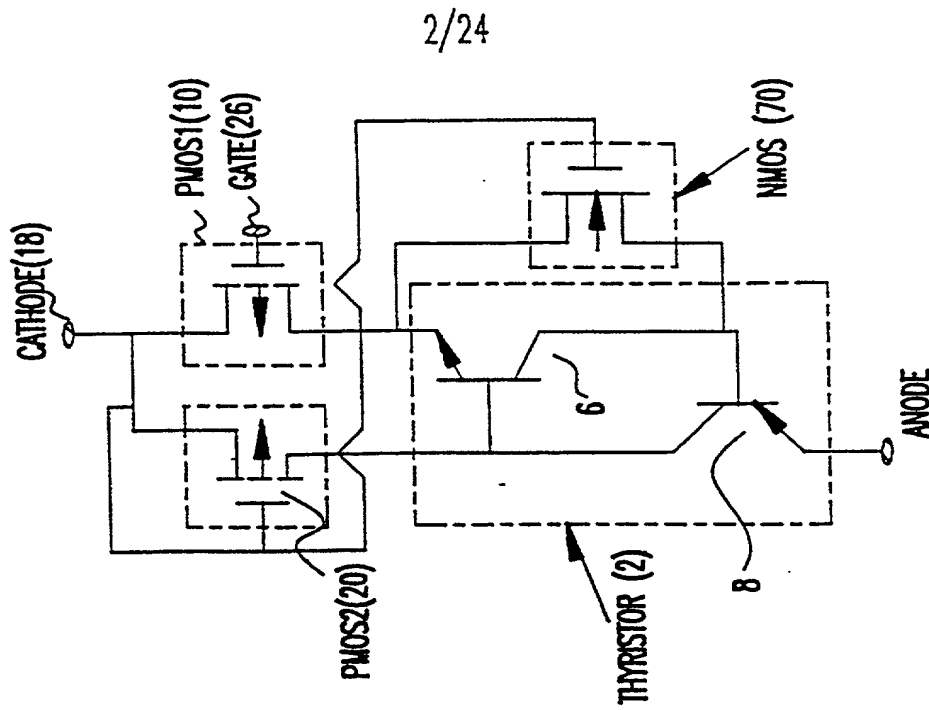


FIG.1D

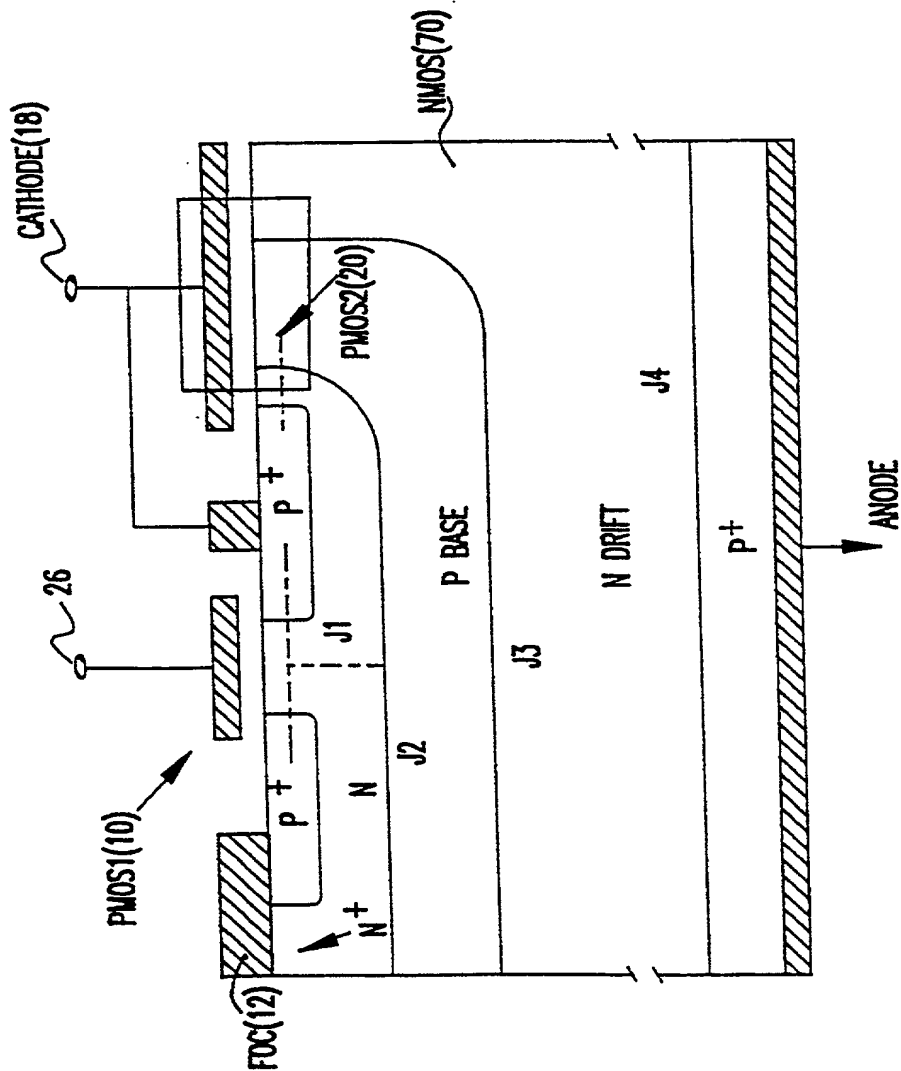


FIG.1C

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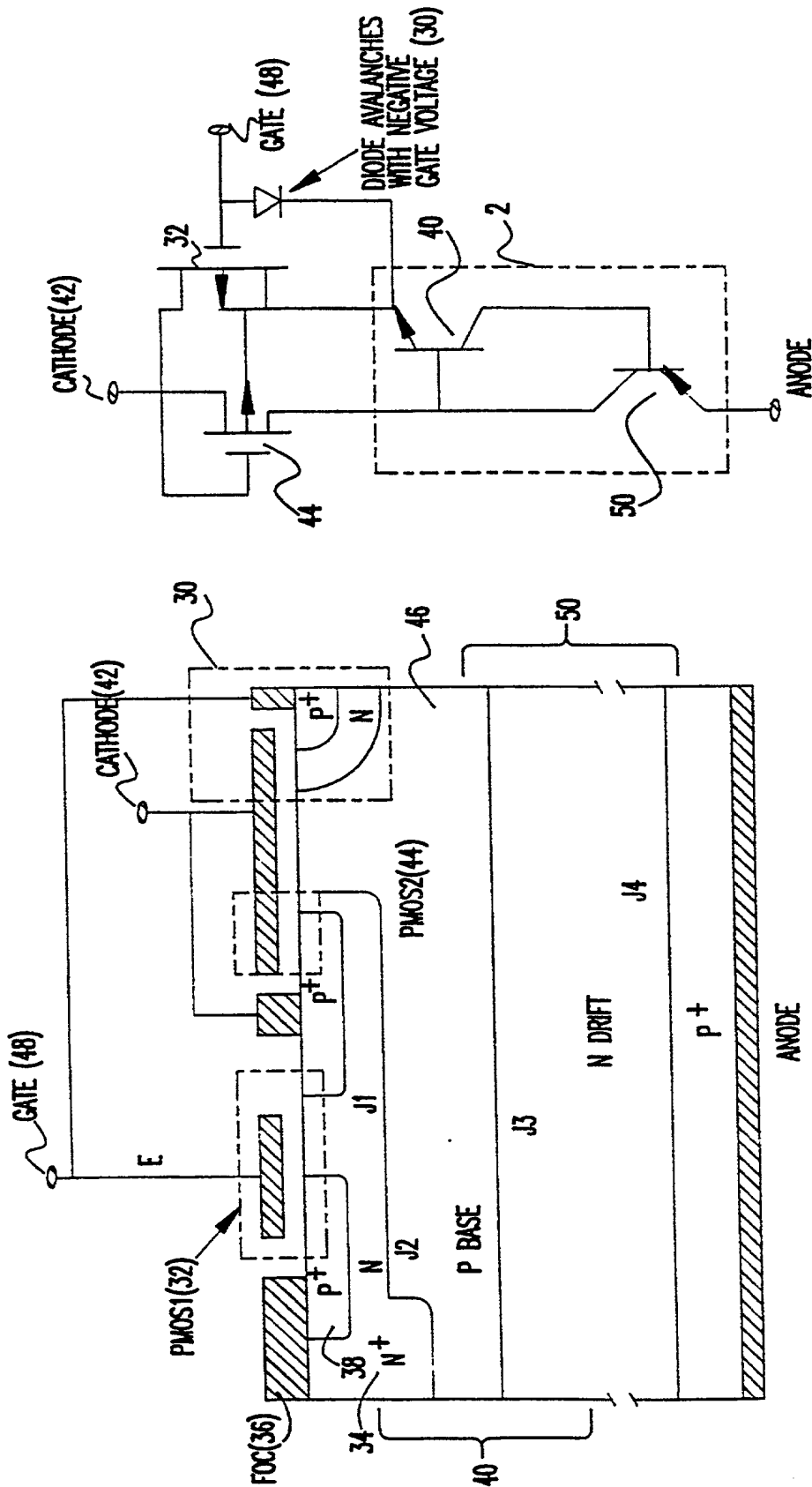


FIG.2B

FIG.2A

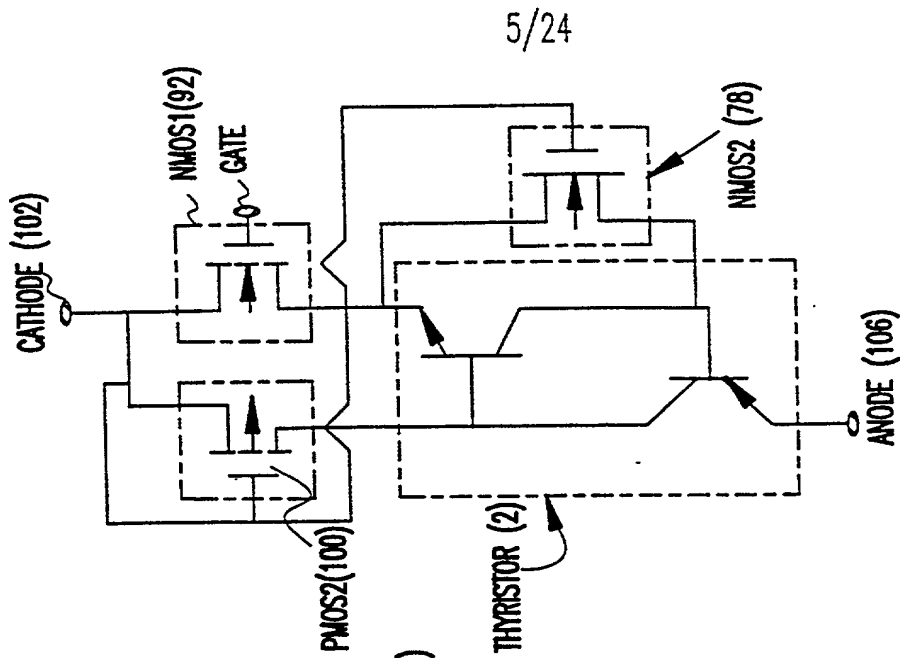


FIG.4B

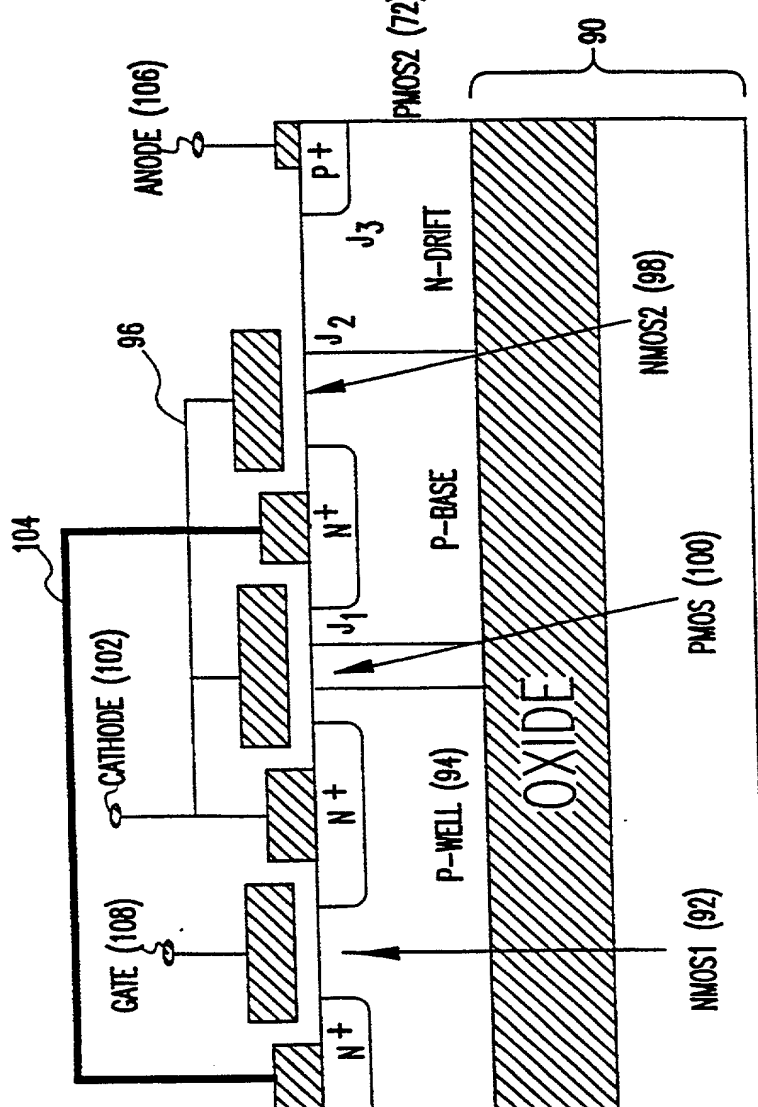


FIG.4A

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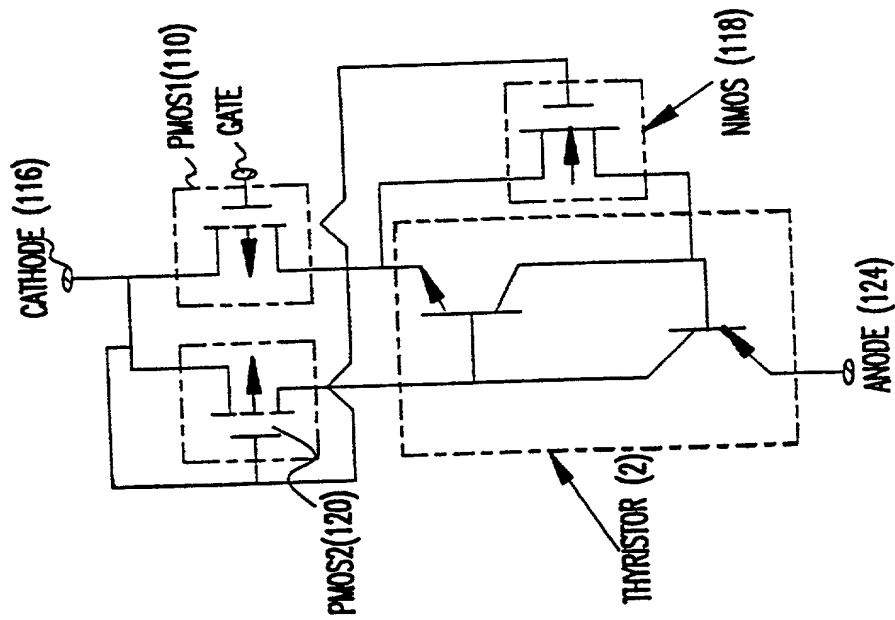


FIG. 5B

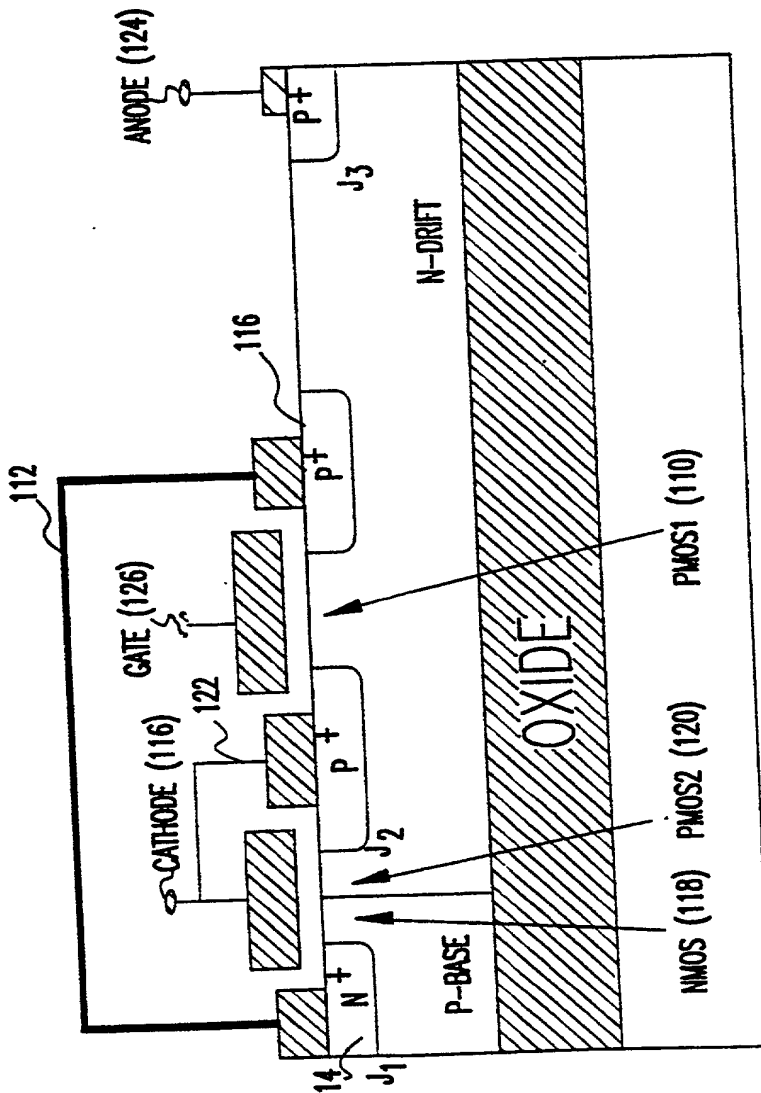


FIG. 5A

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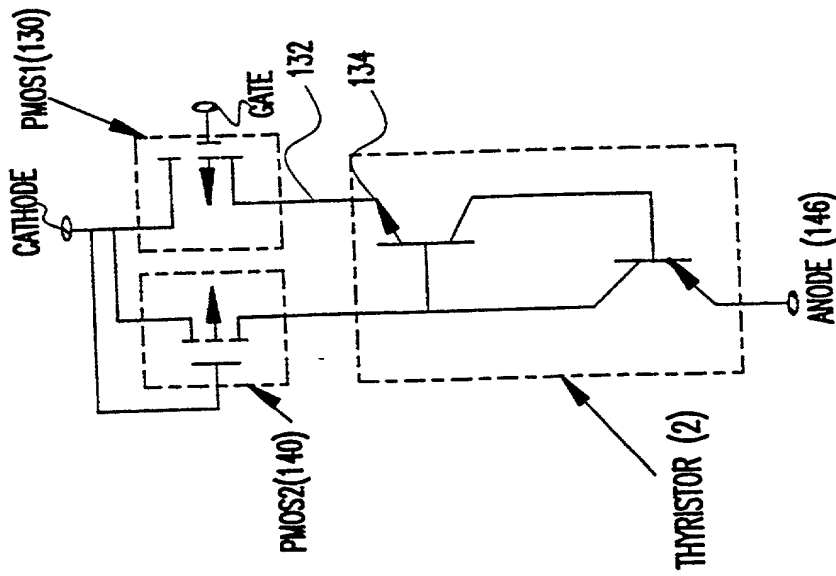


FIG.6B

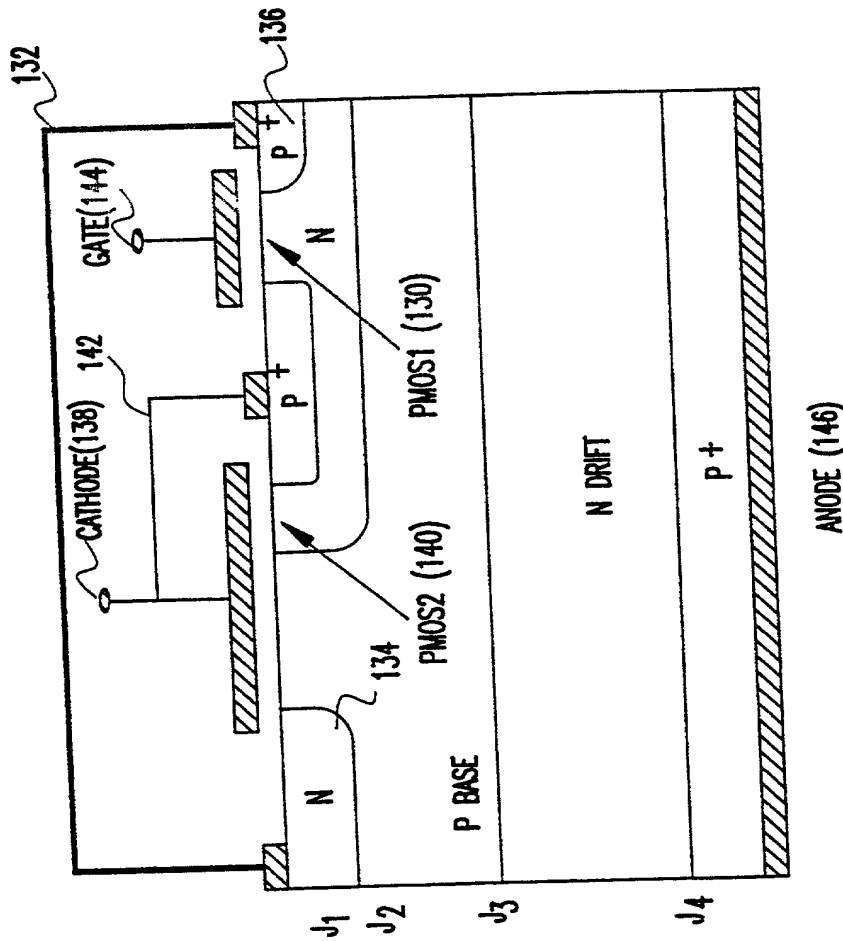


FIG.6A





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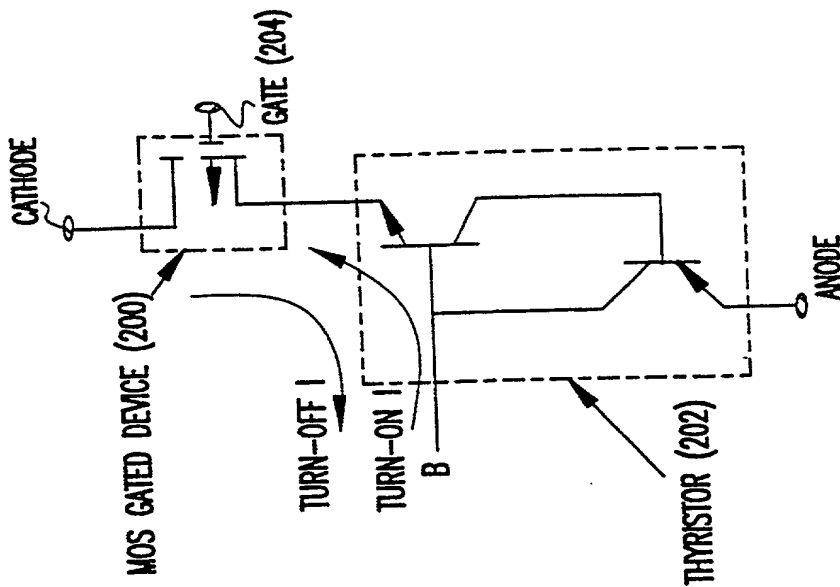


FIG.9B

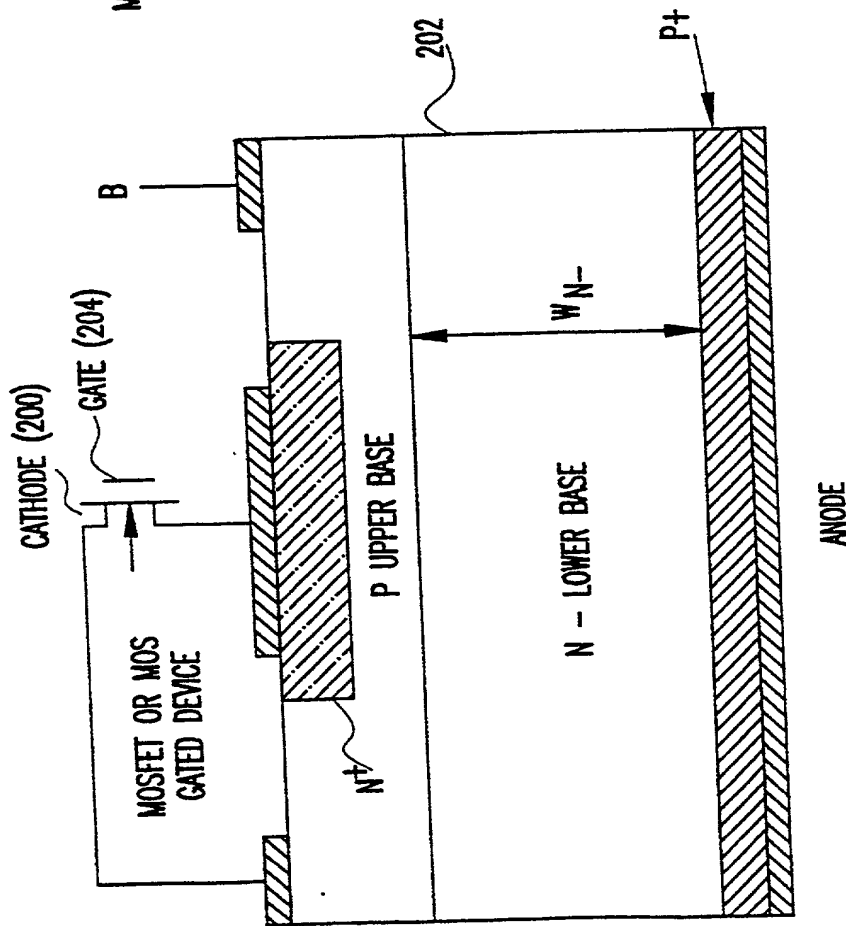


FIG.9A

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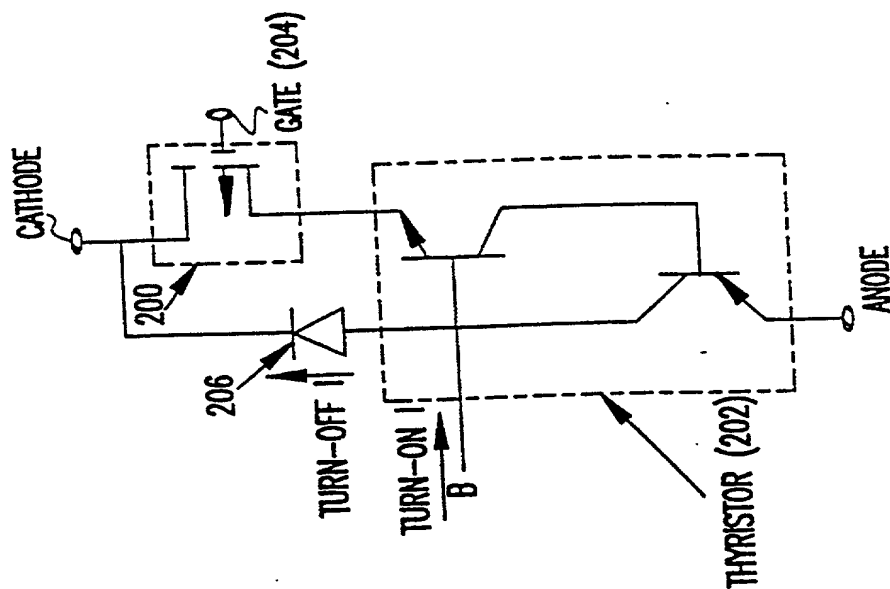


FIG.10B

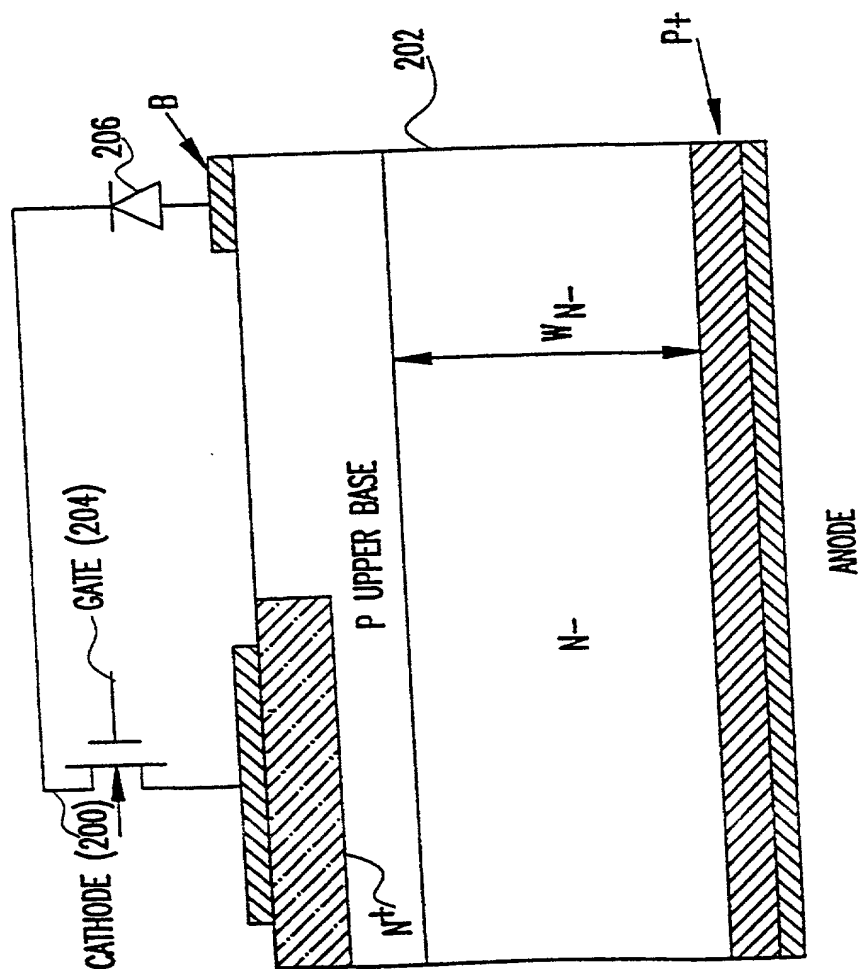


FIG.10A

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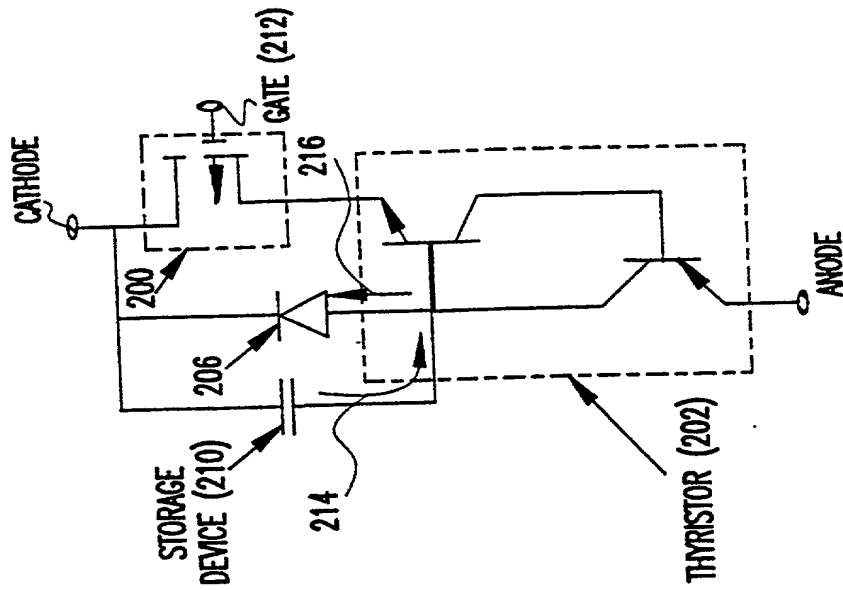


FIG.11B

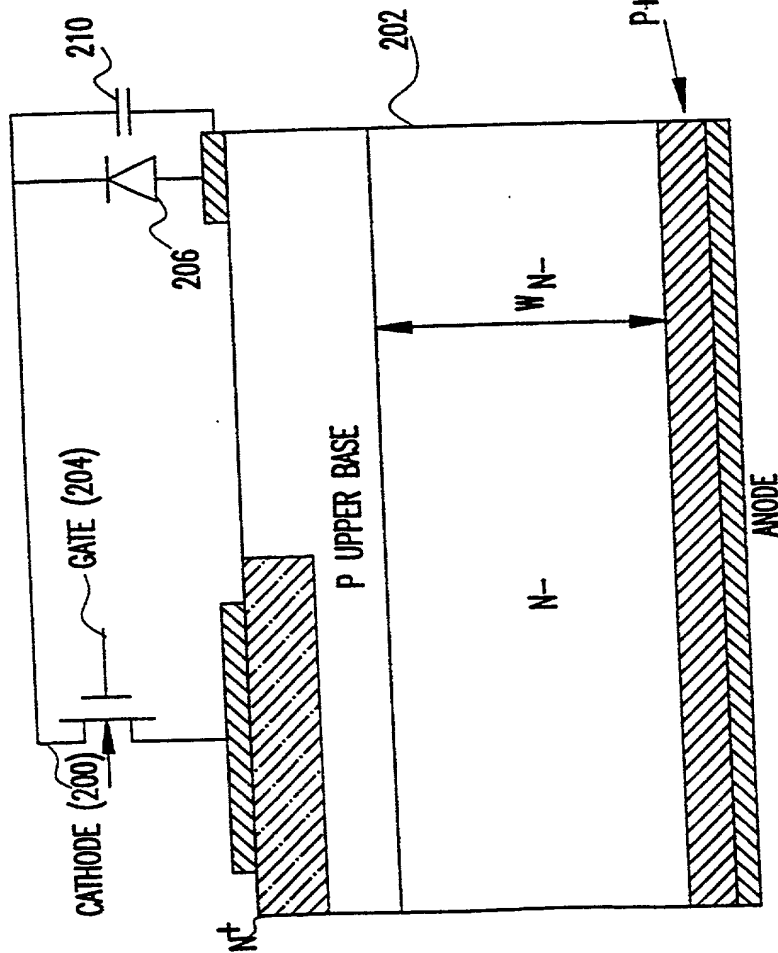


FIG.11A

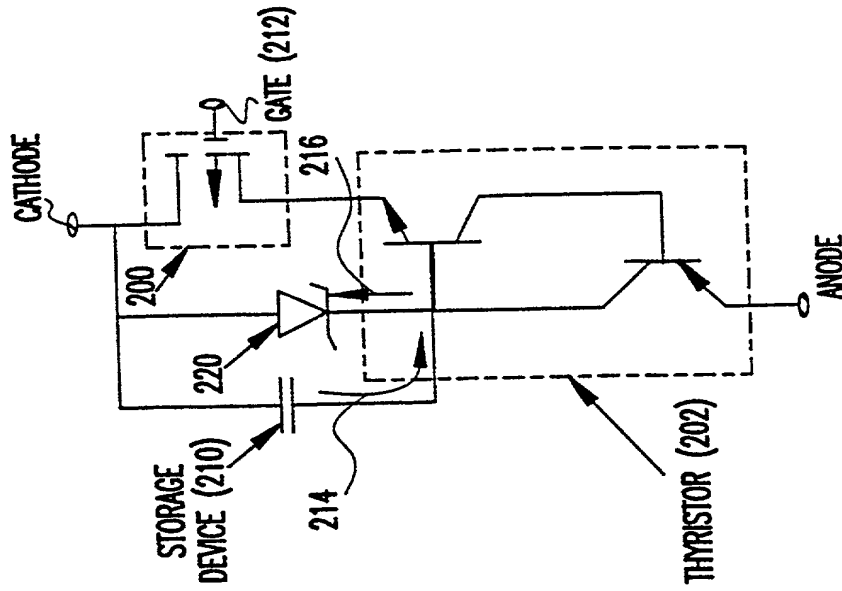


FIG.12B

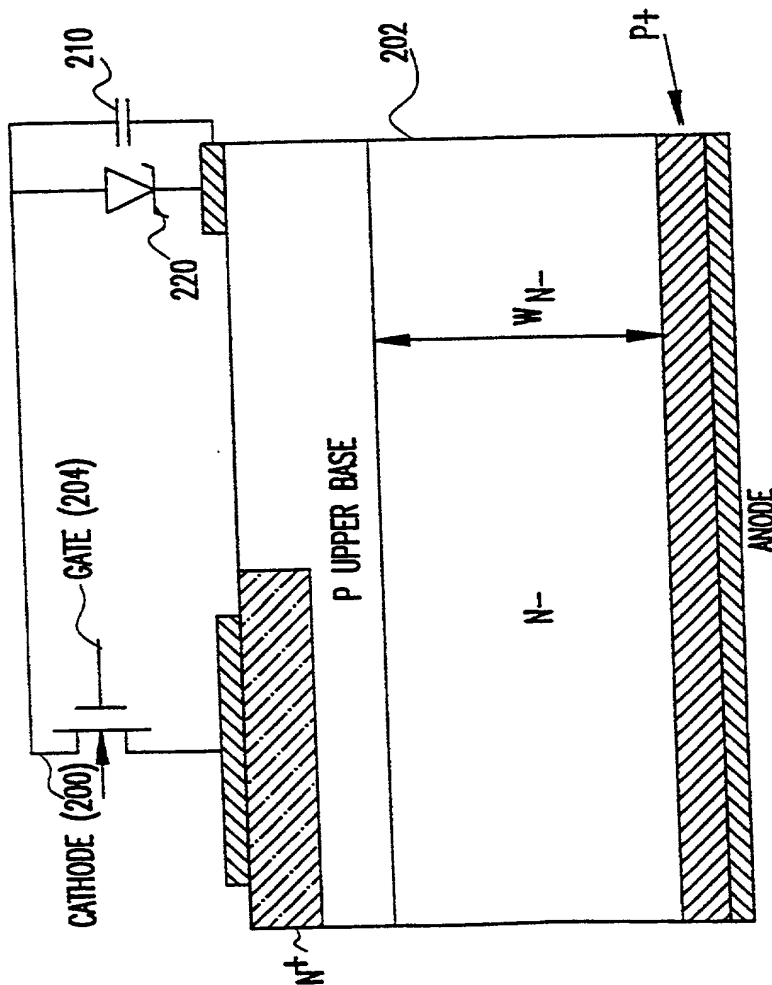
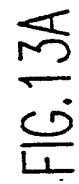
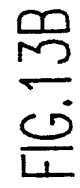


FIG.12A



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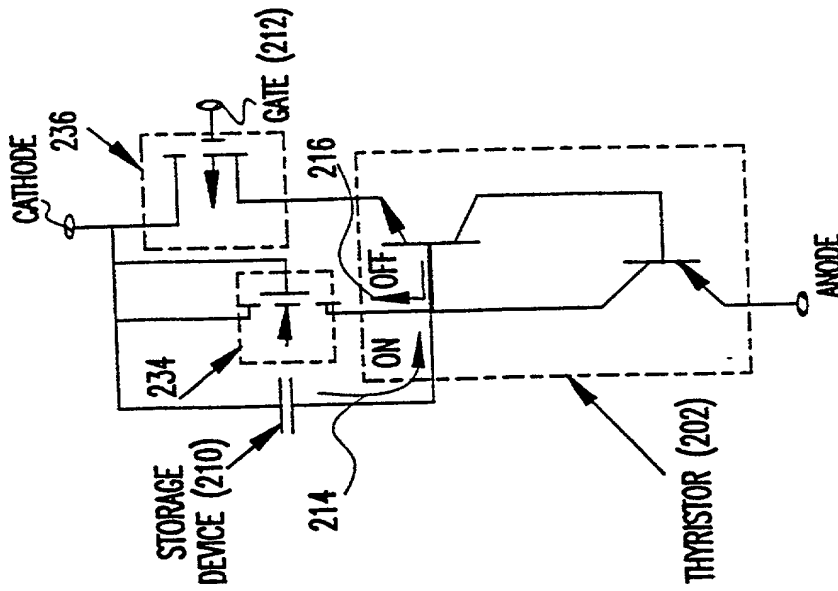


FIG.14B

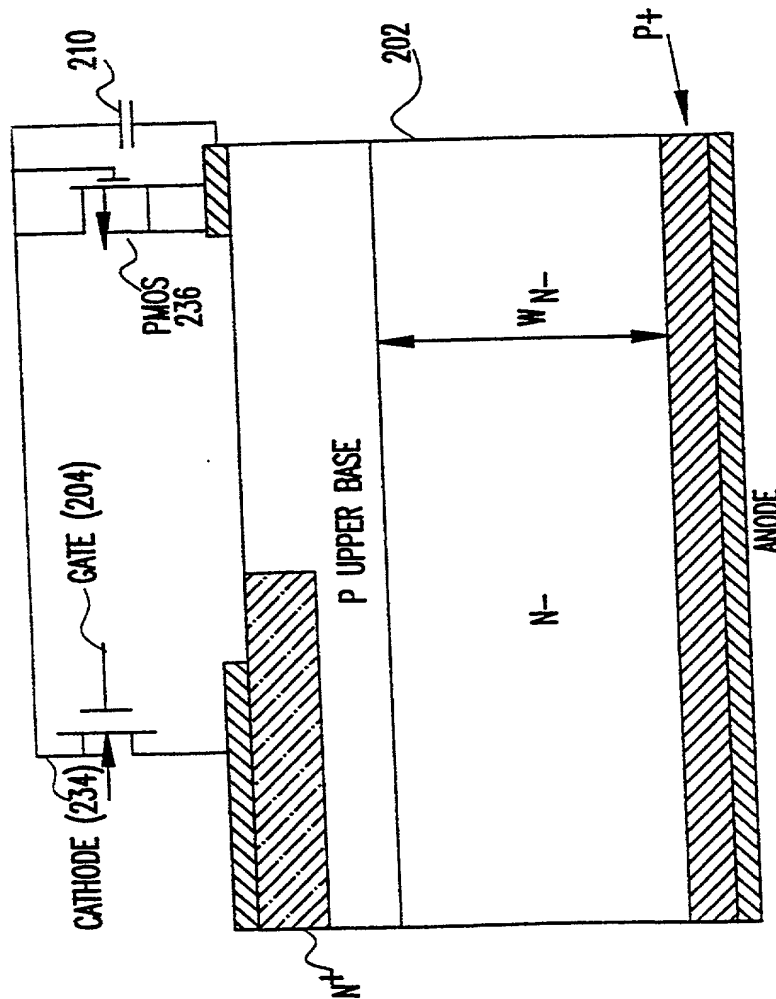


FIG.14A

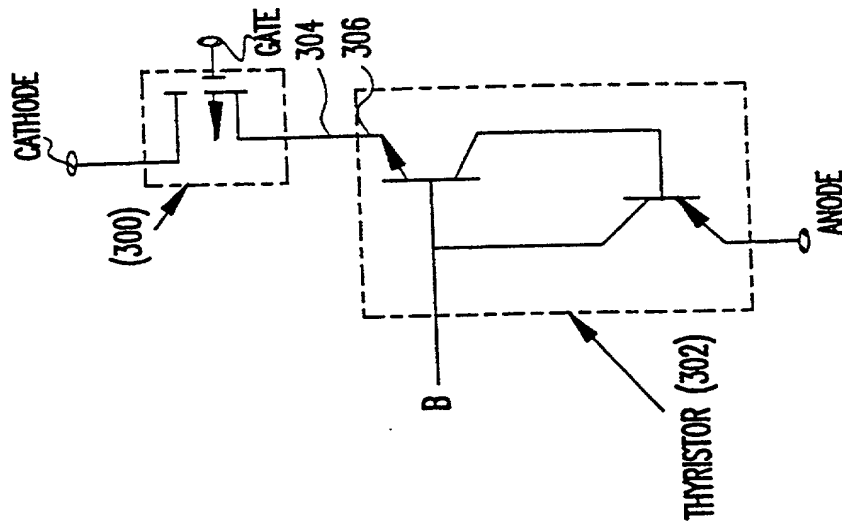


FIG. 15B

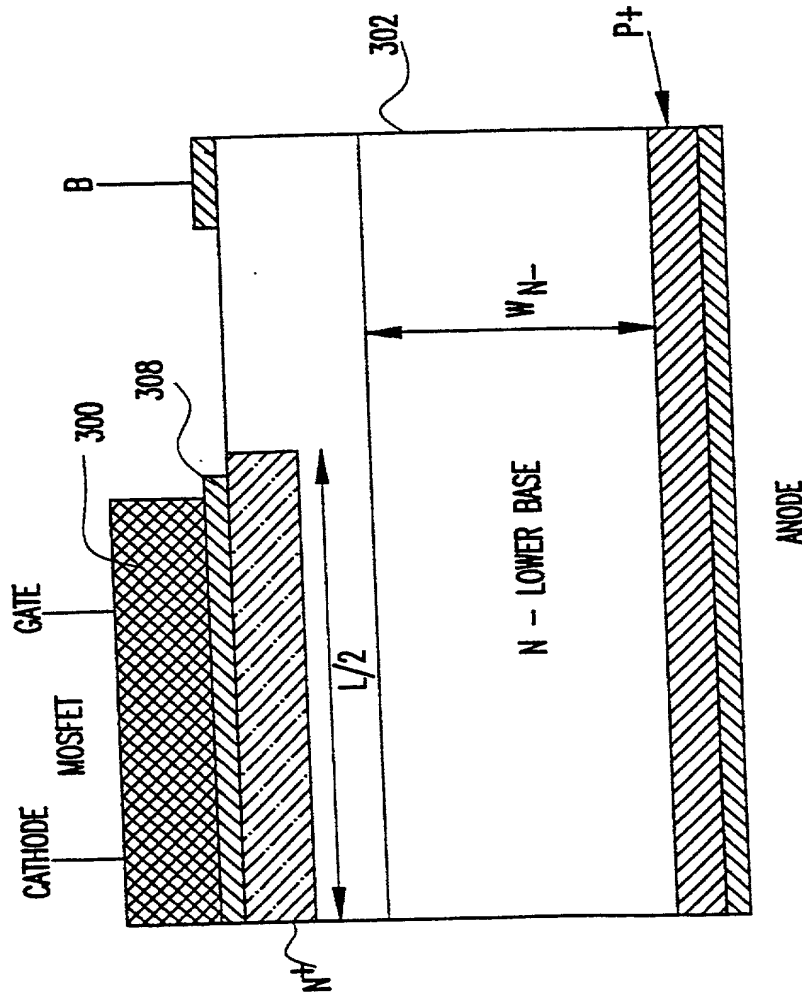
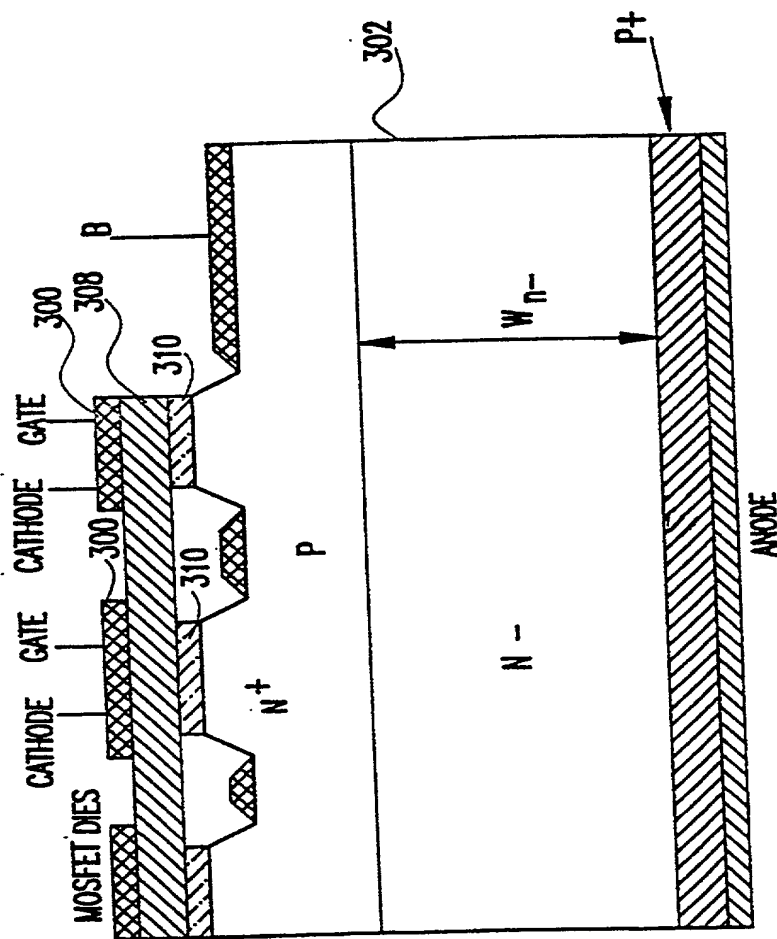
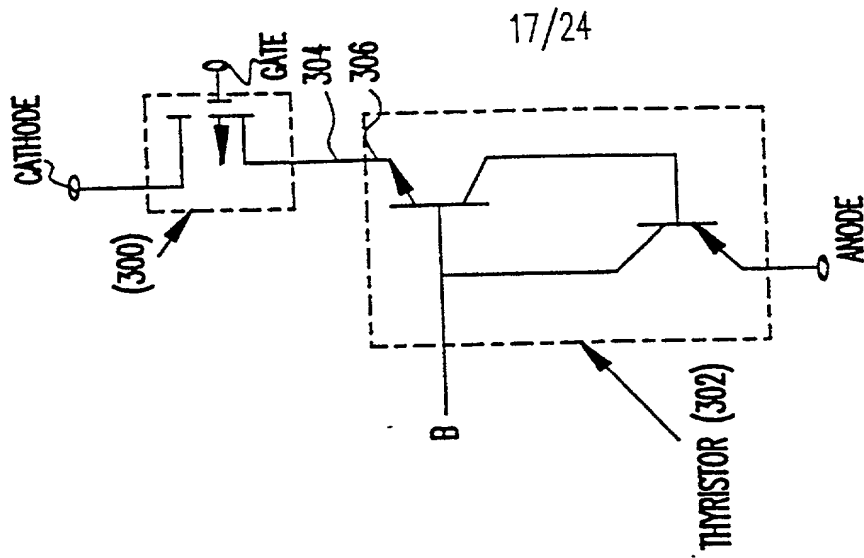


FIG. 15A



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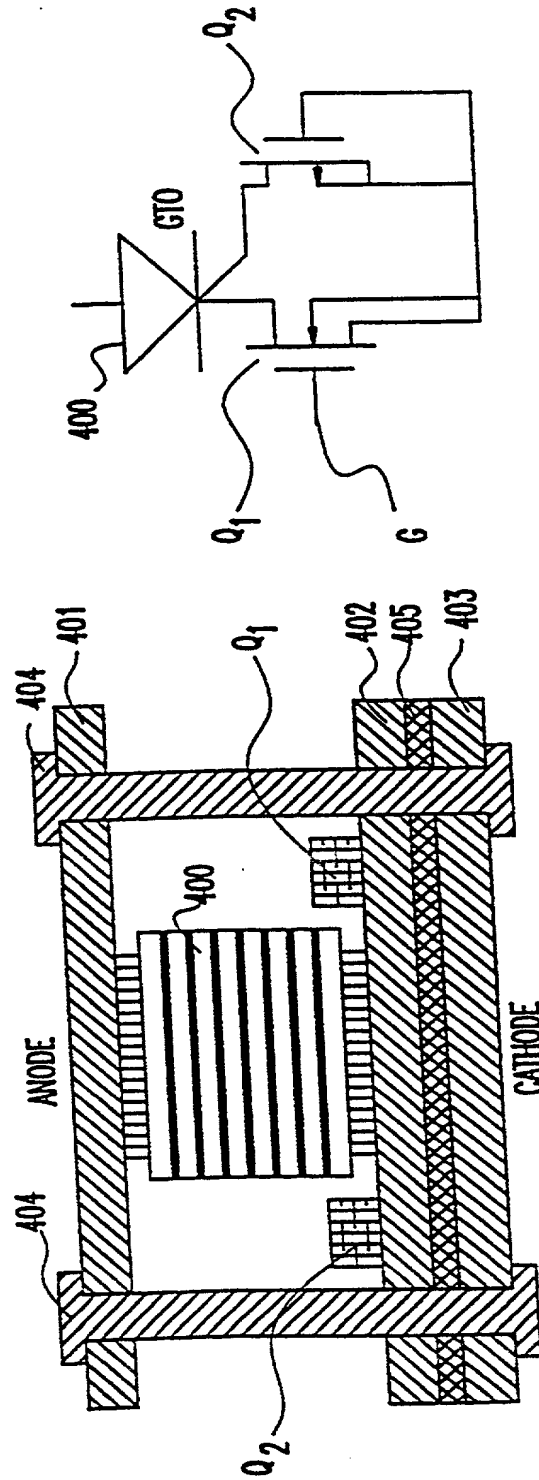


FIG.17B

FIG.17A

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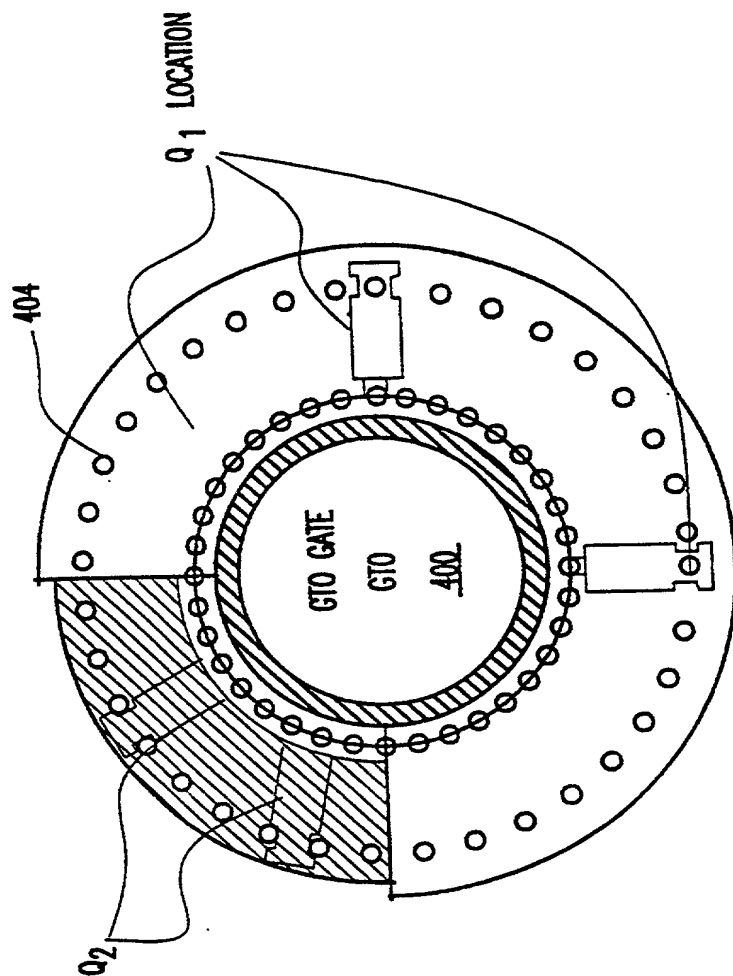


FIG.17C

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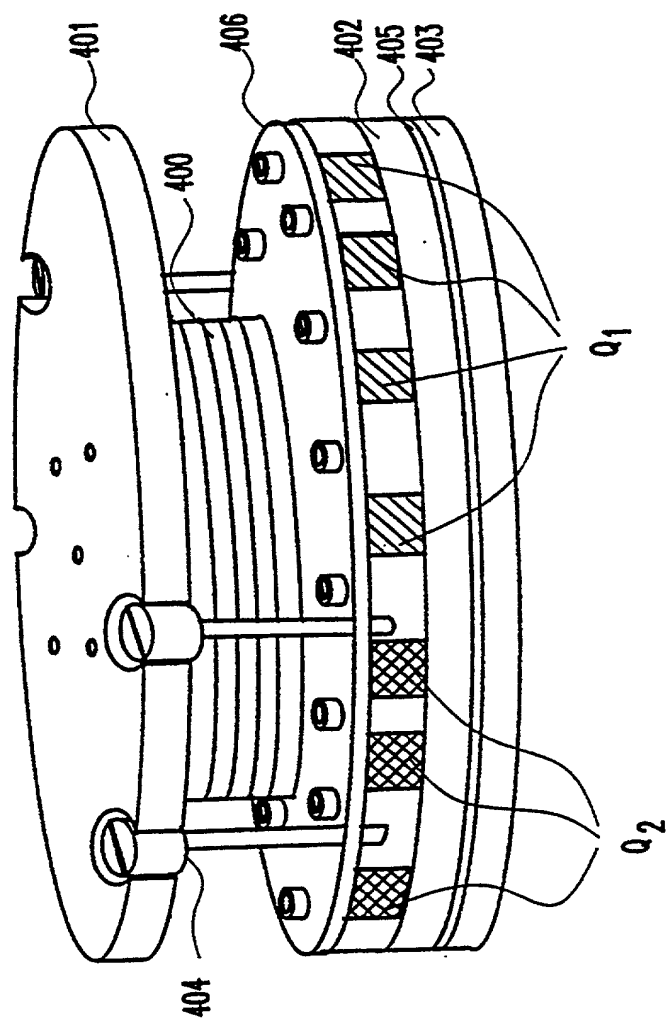


FIG. 17D

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ETO1040S Turn-On

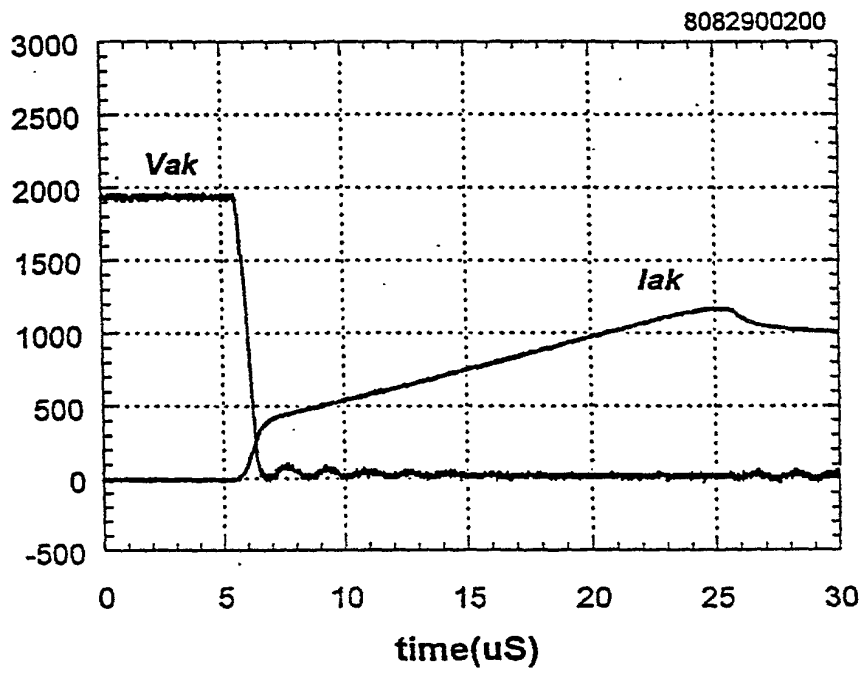


FIG.17E

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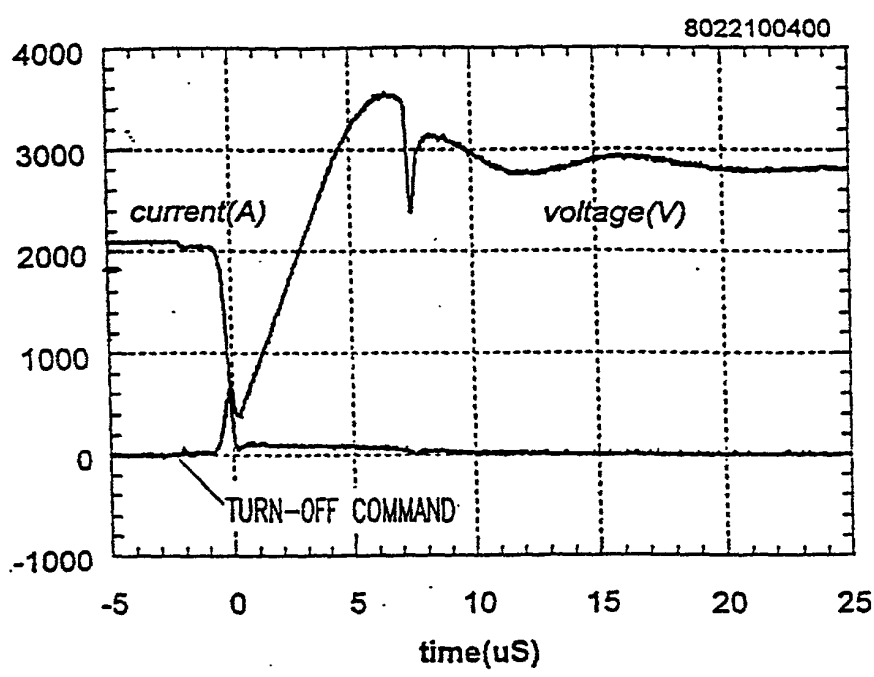


FIG.17F

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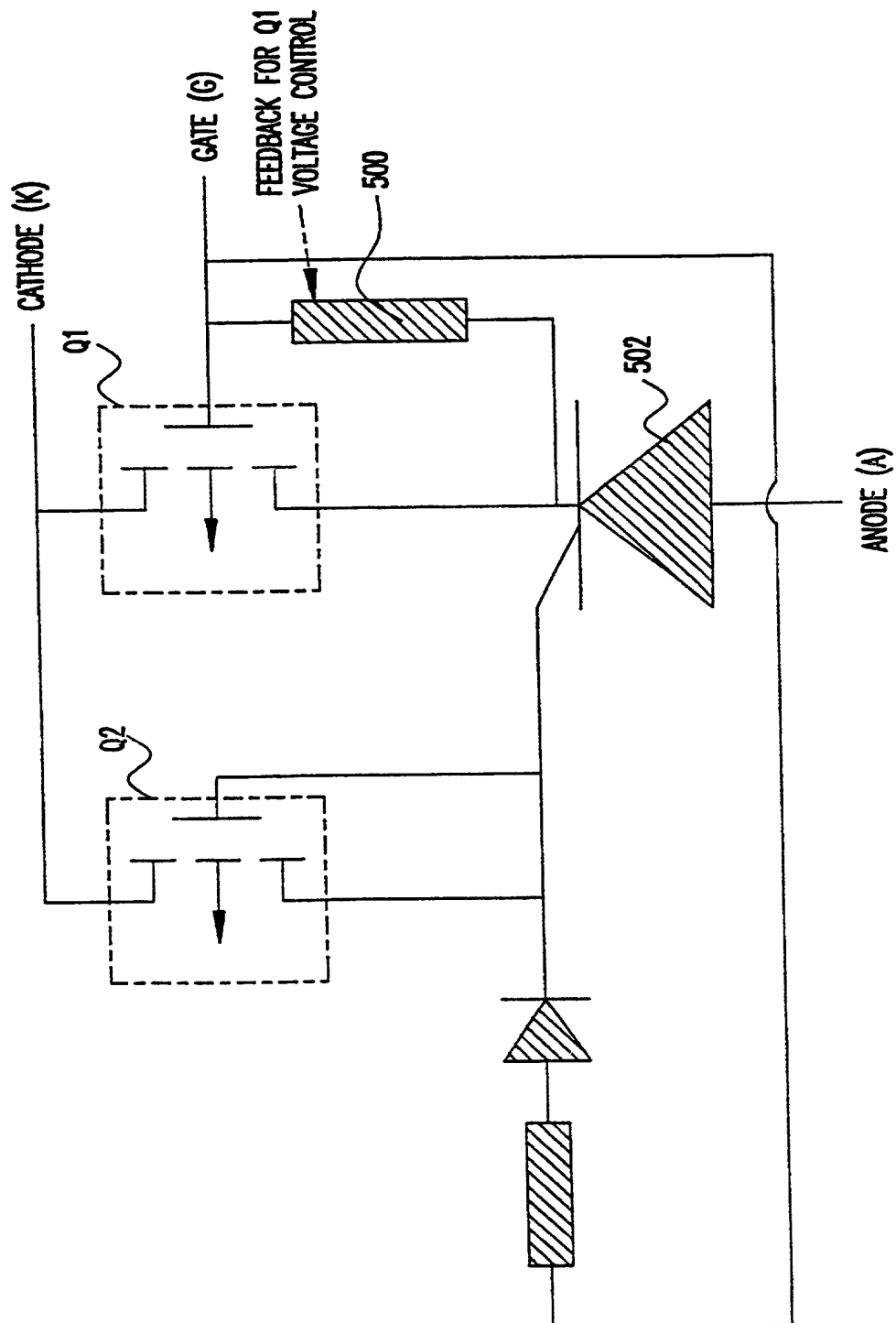


FIG.18

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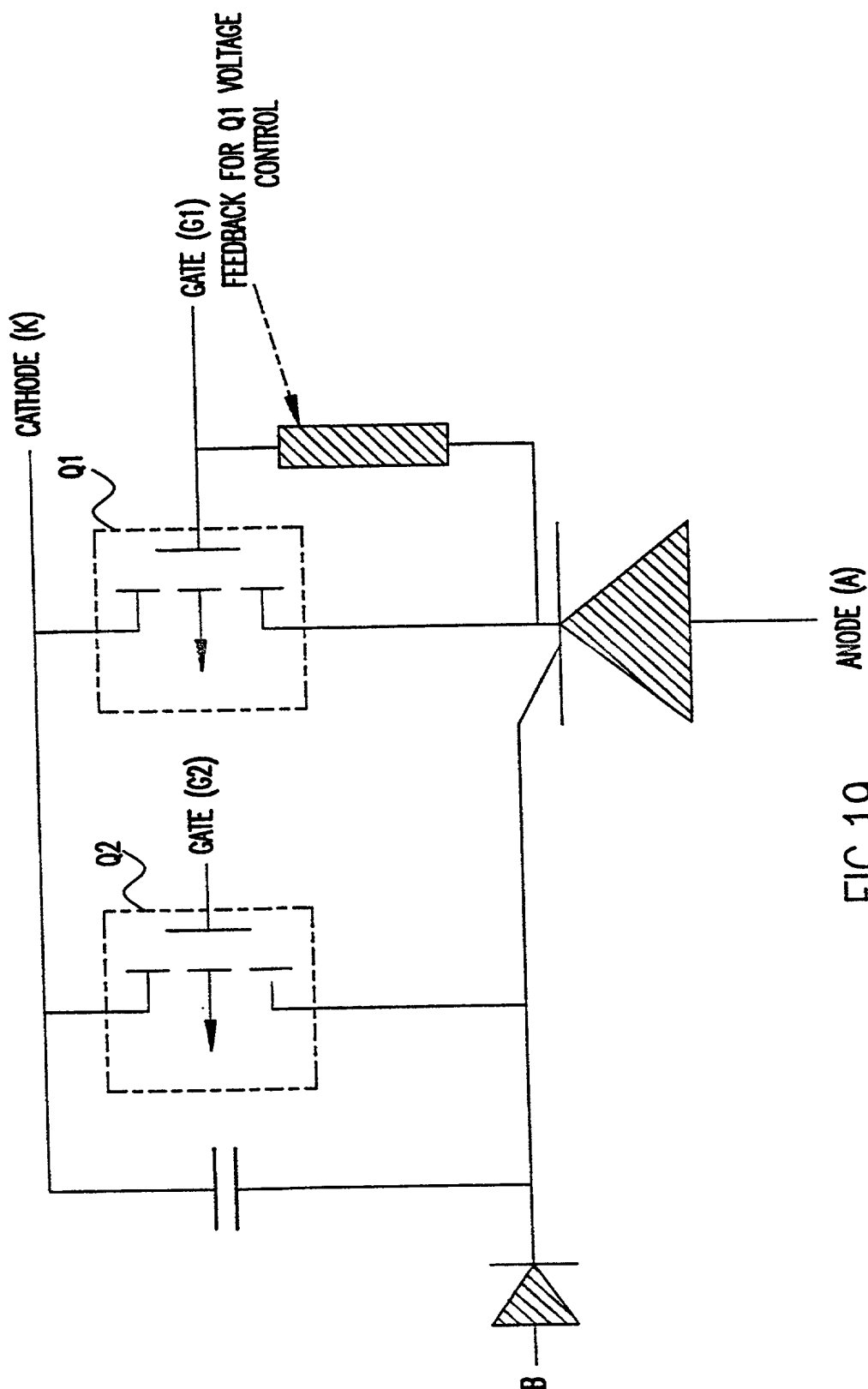


FIG.19

03/01/00 WED 12:45 FAX 5409515292
03/01/00 WED 11:21 FAX 1 540 231 6390
FEB-28-00 10:54 FROM:UCUM LAW OFFICES

VTIP INC.
VPEC VIRGINIA TECH
ID: 7033919035

→→→ WHITHAM

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Docket No: 96-037

DECLARATION AND POWER OF ATTORNEY

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name;

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled

EMITTER TURN-OFF TYRISTORS (ETO)

the specification of which:

(check one) ☒ is attached hereto
☐ was filed on
as Application Serial No.
and was amended on _____
(if applicable)

I hereby state that I have reviewed and understand the contents of the above identified specification, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations, § 1.56

I hereby claim foreign priority benefits under Title 35, United States Code, § 119 of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

Prior Foreign Application(s)

(Number)	(Country)	(Day/Month/Year Filed)	priority claimed yes no
PCT/US98/20594	International	20 September 1998	X

I hereby claim the benefit under Title 35, United States Code, § 119(e) of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, § 112, I acknowledge the duty to disclose material information as defined in Title 37, Code of Federal Regulations, § 1.56 which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

60/060,537	30 September, 1997	Provisional
(Application Serial No.)	(Filing Date)	(Status: patented, pending, abandoned)

and any continuation applications thereof currently pending.

Power of Attorney: As a named inventor, I hereby appoint C. Lamont Whitham, Reg. No. 22,424, Marshall M. Curtis, Reg. No. 33,138, and Michael E. Whitham, Reg. No. 32,635, as attorneys and/or agents to prosecute this application and transact all business in the Patent and Trademark Office connected therewith. All correspondence should be directed to Whitham, Curtis & Whitham, Reston International Center, 11800 Sunrise Valley Dr., Suite 900, Reston, Virginia 20191. Telephone calls should be directed to Whitham, Curtis & Whitham at (703) 391-2510.

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

Docket No: 96-037

Full Name of Sole

or First Inventor

Alex O. Huang

Inventor's Signature

Date

3/1/00

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Citizenship

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VA

Post Office Address

Same as above

Title 37, Code of Federal Regulations, § 1.56:

- (a) A patent by its very nature is affected with a public interest. The public interest is best served, and the most effective patent examination occurs when, at the time an application is being examined, the Office is aware of and evaluates the teachings of all information material to patentability. Each individual associated with the filing and prosecution of a patent application has a duty of candor and good faith toward the Patent and Trademark Office, which includes a duty to disclose to the Office all information known to that individual to be material to patentability as defined in this section. The duty to disclose information exists with respect to each pending claim until the claim is canceled or withdrawn from consideration, or the application becomes abandoned.
- (b) Under this section, information is material to patentability when it is not cumulative to information already of record or being made of record in the application, and (1) it establishes, by itself or in combination with other information, a prima facie case of unpatentability; or (2) it refutes, or is inconsistent with, a position the applicant takes in: (i) opposing an argument of unpatentability relied on by the Office, or (ii) asserting an argument of patentability.